



SPORTON LAB.

Certificate No: **EC310805**

CERTIFICATE

● **EQUIPMENT: External four bay RAID system**

MODEL NO. : GR5630-WSB3+, SR4-WBS3+

APPLICANT : RAIDON TECHNOLOGY, INC.

7F-9, No. 16, Lane 609, Sec. 5, Chung-Hsin Rd.,
San-Chung Dist., New Taipei City, Taiwan (R.O.C)



I HEREBY

CERTIFY THAT:

THE MEASUREMENTS SHOWN IN THIS TEST REPORT WERE MADE IN
ACCORDANCE WITH THE PROCEDURES GIVEN IN **EUROPEAN COUNCIL
DIRECTIVE 2004/108/EC**. THE EQUIPMENT WAS **PASSED** THE TEST
PERFORMED ACCORDING TO

**European Standard EN 55022:2010 Class B,
EN 61000-3-2:2006/A1:2009/A2:2009, EN 61000-3-3:2008 and
EN 55024:2010 (IEC 61000-4-2:2008, IEC 61000-4-3:2006/A1:2007/A2:2010,
IEC 61000-4-4:2004/A1:2010, IEC 61000-4-5:2005, IEC 61000-4-6:2008,
IEC 61000-4-8:2009, IEC 61000-4-11:2004).**

THE TEST WAS CARRIED OUT ON **Mar. 15, 2013** AT
SPORTON INTERNATIONAL INC. LAB.

Jack Deng

Engineering Manager

CE EMC TEST REPORT

according to

**European Standard EN 55022:2010 Class B,
EN 61000-3-2:2006/A1:2009/A2:2009, EN 61000-3-3:2008 and
EN 55024:2010 (IEC 61000-4-2:2008,
IEC 61000-4-3:2006/A1:2007/A2:2010, IEC 61000-4-4:2004/A1:2010,
IEC 61000-4-5:2005, IEC 61000-4-6:2008,
IEC 61000-4-8:2009, IEC 61000-4-11:2004)**

Equipment : External four bay RAID system

Model No. : GR5630-WSB3+, SR4-WBS3+

Applicant : **RAIDON TECHNOLOGY, INC.**
7F-9, No. 16, Lane 609, Sec. 5, Chung-Hsin Rd.,
San-Chung Dist., New Taipei City, Taiwan (R.O.C)

Statement

- The test result refers exclusively to the test presented test model / sample.
- Without written approval of SPORTON International Inc., the test report shall not be reproduced except in full.
- This test report is only applicable to European Community.

SPORTON International Inc.

6F, No. 106, Sec. 1, Hsin Tai Wu Rd., Hsi Chih, Taipei Hsien, Taiwan, R.O.C.

Table of Contents

History of this test report.....	iv
CERTIFICATE OF COMPLIANCE.....	1
1. General Description of Equipment under Test.....	2
1.1. Applicant.....	2
1.2. Manufacturer	2
1.3. Basic Description of Equipment under Test	2
1.4. Feature of Equipment under Test	2
2. Summary of the Test Result	3
2.1. Emission Tests	3
2.2. Immunity Tests	3
3. Test Configuration of Equipment under Test	4
3.1. Test Manner	4
3.2. Description of Test System	5
4. Test Software	7
5. General Information of Test.....	8
5.1. Test Facility	8
5.2. Test Voltage	8
5.3. Measurement Procedure.....	8
5.4. Test in Compliance with	8
5.5. Frequency Range Investigated	9
5.6. Test Distance	9
6. Conducted Emissions Measurement	10
6.1. Limits for conducted disturbance at mains terminals	10
6.2. Description of Major Test Instruments	11
6.3. Test Procedures.....	11
6.4. Typical Test Setup Layout of AC Powerline Conducted Emissions	12
6.5. Test Result of AC Powerline Conducted Emission	13
7. Radiated Emission Measurement	15
7.1. Limits for radiated disturbance	15
7.2. Description of Major Test Instruments	16
7.3. Test Procedures.....	17
7.4. Typical Test Setup Layout of Radiated Emissions.....	18
7.5. Test Result of Radiated Emission for Below 1GHz.....	19
7.6. Test Result of Radiated Emission for Above 1GHz	23
8. Harmonic Current Emissions Measurement.....	27
9. Voltage Fluctuations and Flicker Measurement.....	28
9.1. Standard.....	28
9.2. Test Procedure.....	28
9.3. Test Equipment Settings	28
9.4. Typical Test Setup Layout of Voltage Fluctuations and Flicker	28
9.5. Test Result of Voltage Fluctuation and Flicker.....	29

10. Electrostatic Discharge Immunity Measurement (ESD)	30
10.1. Test Setup.....	30
10.2. Test Setup for Tests Performed in Laboratory.....	31
10.3. ESD Test Procedure	32
10.4. Test Severity Levels.....	33
10.5. Test Points	34
11. Radio Frequency Electromagnetic Field Immunity Measurement (RS).....	35
11.1. Test Record	35
11.2. Test Setup.....	36
11.3. Test Procedure	36
11.4. Test Severity Levels.....	37
12. Electrical Fast Transient/Burst Immunity Measurement (EFT/BURST)	38
12.1. Test Record	38
12.2. Test setup	39
12.3. Test on Power Line	39
12.4. Test on Communication Lines	40
12.5. Test Procedure	40
12.6. Test Severity Levels.....	40
13. Surge Immunity Measurement	41
13.1. Test Record	42
13.2. Test Severity Levels.....	42
13.3. Test Procedure	43
13.4. Operating Condition	44
14. Conducted Disturbances Induced by Radio-Frequency Field Immunity Measurement (CS).....	45
14.1. Test Record	45
14.2. Test Severity Levels.....	45
14.3. Operating Condition	45
14.4. Test Procedure	46
15. Power Frequency Magnetic Field immunity Measurement (PFMF).....	47
15.1. Test Record	47
15.2. Test Setup.....	47
16. Voltage Dips and Voltage Interruptions Immunity Measurement (DIP)	48
16.1. Test Record of Voltage Interruption	48
16.2. Test Record of Voltage Dips	48
16.3. Testing Requirement and Procedure	49
16.4. Test Conditions	49
16.5. Operating Condition	49
17. Photographs of Test Configuration	50
17.1. Photographs of AC Powerline Conducted Emissions Test Configuration.....	50
17.2. Photographs of Radiated Emissions Test Configuration	51
17.3. Photographs of Harmonic, Flicker, Surge, Dip Test Configuration	53
17.4. Photographs of ESD Immunity Test Configuration	54
17.5. Photographs of RS Immunity Test Configuration.....	55
17.6. Photographs of EFT/BURST Immunity Test Configuration.....	56
17.7. Photographs of CS Immunity Test Configuration.....	57
17.8. Photographs of PFMF immunity test Configuration	58

18. List of Measuring Equipment Used	59
19. Uncertainty of Test Site	61
Appendix A. Photographs of EUT.....	A1 ~ A15

History of this test report

Report No.	Version	Issue Date	Description
EC310805	Rev.01	Mar. 26, 2013	Initial issue of report

CERTIFICATE OF COMPLIANCE

according to

**European Standard EN 55022:2010 Class B,
EN 61000-3-2:2006/A1:2009/A2:2009, EN 61000-3-3:2008 and
EN 55024:2010 (IEC 61000-4-2:2008,
IEC 61000-4-3:2006/A1:2007/A2:2010, IEC 61000-4-4:2004/A1:2010,
IEC 61000-4-5:2005, IEC 61000-4-6:2008,
IEC 61000-4-8:2009, IEC 61000-4-11:2004)**

Equipment : External four bay RAID system

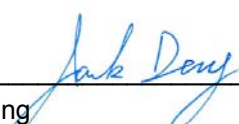
Model No. : GR5630-WSB3+, SR4-WBS3+

Applicant : **RAIDON TECHNOLOGY, INC.**
7F-9, No. 16, Lane 609, Sec. 5, Chung-Hsin Rd.,
San-Chung Dist., New Taipei City, Taiwan (R.O.C)

I **HEREBY** CERTIFY THAT :

The measurements shown in this test report were made in accordance with the procedures given in **EUROPEAN COUNCIL DIRECTIVE 2004/108/EC**. The equipment was **passed** the test performed according to **European Standard EN 55022:2010 Class B, EN 61000-3-2:2006/A1:2009/A2:2009, EN 61000-3-3:2008 and EN 55024:2010 (IEC 61000-4-2:2008, IEC 61000-4-3:2006/A1:2007/A2:2010, IEC 61000-4-4:2004/A1:2010, IEC 61000-4-5:2005, IEC 61000-4-6:2008, IEC 61000-4-8:2009, IEC 61000-4-11:2004).**

The test was carried out on Mar. 15, 2013 at **SPORTON International Inc.** LAB.



Jack Deng
Engineering Manager

SPORTON International Inc.

6F, No. 106, Sec. 1, Hsin Tai Wu Rd., Hsi Chih, Taipei Hsien, Taiwan, R.O.C.

1. General Description of Equipment under Test

1.1. Applicant

RAIDON TECHNOLOGY, INC.
7F-9, No. 16, Lane 609, Sec. 5, Chung-Hsin Rd., San-Chung Dist.,
New Taipei City, Taiwan (R.O.C)

1.2. Manufacturer

Same as 1.1

1.3. Basic Description of Equipment under Test

Equipment : External four bay RAID system
Model No. : GR5630-WSB3+, SR4-WBS3+
Trade Name : RAIDON, STARDOM
1394B Cable : D-Shielded, 1.8 m
e-SATA Cable : D-Shielded, 1 m
USB Cable : D-Shielded, 1 m

Associated with interface cables

1394B Cable : D-Shielded, 1.8 m
Data Cable Type : Please see section 3.2 of this test report for details
Power Supply Type : From Switching Power Supply
AC Power Cord : Non-Shielded, 1.8 m, 3 pin

1.4. Feature of Equipment under Test

Please refer to user manual.

2. Summary of the Test Result

2.1. Emission Tests

Emissions			
Test Standard	Description of Test	Result	Remark
EN 55022:2010	AC Power Conducted Emissions	Complies	-
EN 55022:2010	Telecommunication Ports Conducted	-	N/A
EN 55022:2010	Radiated Emissions (Below 1GHz)	Complies	-
	Radiated Emissions (Above 1GHz)	Complies	-
EN 61000-3-2:2006/A1:2009/A2:2009	Harmonic Current Emissions	-	N/A
EN 61000-3-3:2008	Voltage Fluctuations and Flicker	Complies	-

Remark: The "N/A" is means not applicable.

2.2. Immunity Tests

Applicable Standard : EN 55024:2010			
Test Standard	Description of Test	Result	Criteria
IEC 61000-4-2:2008	ESD (EUT of Enclosure)	Complies	B
IEC 61000-4-3:2006/A1:2007/A2:2010	RS (EUT of Enclosure)	Complies	A
IEC 61000-4-4:2004/A1:2010	EFT (EUT of AC Power Port)	Complies	A
IEC 61000-4-4:2004/A1:2010	EFT (EUT of signal ports and telecommunication ports)	-	-
IEC 61000-4-5:2005	Surge (EUT of AC Power Port)	Complies	A
IEC 61000-4-5:2005	Surge (EUT of signal ports and telecommunication ports)	-	-
IEC 61000-4-6:2008	CS (EUT of AC Power Port)	Complies	A
IEC 61000-4-6:2008	CS (EUT of signal ports and telecommunication ports)	-	-
IEC 61000-4-8:2009	PFMF (EUT of Enclosure)	Complies	A
IEC 61000-4-11:2004	DIP (EUT of AC Power Port)	Complies	C/A/A

3. Test Configuration of Equipment under Test

3.1. Test Manner

- a. The EUT has been associated with personal computer and peripherals pursuant to European Standard EN 55022 and EN 55024.
- b. The equipment under test were performed the following test modes:

Test Items	Description of test modes
AC Conducted Emission	Mode 1. R/W+ 1394B, external 1394B HDD Mode 2. R/W+ e-SATA Mode 3. R/W+ USB3.0 Cause "mode 1" generated the worst test result; it was reported as final data.
Radiated Emissions	Mode 1. R/W+ 1394B, external 1394B HDD Mode 2. R/W+ e-SATA Mode 3. R/W+ USB3.0 < below 1GHz > Cause "mode 1" generated the worst test result; it was reported as final data. < above 1GHz > Cause "mode 3" is highest frequency of the internal sources of the EUT; it was reported as final data.
Harmonic and Flicker Emissions	Mode 1. R/W+ 1394B, external 1394B HDD
EMS	Mode 1. R/W+ 1394B, external 1394B HDD

- c. Frequency range investigated: Conduction 150 kHz to 30 MHz, Radiation 30 MHz to 6,000 MHz.
- d. Frequency range investigated immunity test: CS 150 kHz to 80 MHz, RS 80 MHz to 1,000 MHz.

3.2. Description of Test System

< EMI ><Conducted and Radiated below 1GHz>

No.	Peripheral	Manufacturer	Model Number	FCC ID	Cable / Spec. Description	Placed
1	Personal Computer	DELL	DCTA	DoC	N/A	Local
2	LCD Monitor	DELL	E198WFPf	DoC	D-SUB Cable, D-Shielded, 1.8m	Local
3	Keyboard	DELL	SK-8175	DoC	USB Cable, AL-F-Shielded, 1.8m	Local
4	Mouse	DELL	MOC5UO	DoC	USB Cable, AL-F-Shielded, 1.8m	Local
5	Printer	HP	C2642X(DJ400)	B94C2642X	LPT Cable, D-Shielded, 1.2m	Local
6	Modem	ACEEX	DM1414	IFAXDM1414	RS-232 Cable, D-Shielded, 1.15m	Local
7	1394B HDD	ONNTO	AT-S111	DoC	1394B Cable, D-Shielded, 1.8m	Local
8	HDD	HITACHI	HDS728080PLA380	DoC	80GB	Local
9	HDD x3	HITACHI	HDS721032CLA362	DoC	320GB	Local

< EMI ><Radiated above 1GHz>

No.	Peripheral	Manufacturer	Model Number	FCC ID	Cable / Spec. Description	Placed
1	Personal Computer	DELL	DCTA	DoC	N/A	Local
2	LCD Monitor	DELL	2408WFPb	DoC	D-SUB Cable, D-Shielded, 1.8m	Local
3	Keyboard	Microsoft	1366	DoC	PS/2 Cable, AL-F-Shielded, 2m	Local
4	Mouse	Microsoft	1113	JNZ211443	PS/2 Cable, Non-Shielded, 1.8m	Local
5	Printer	HP	C2642X(DJ400)	B94C2642X	LPT Cable, D-Shielded, 1.8m	Local
6	Modem	ACEEX	DM1414	IFAXDM1414	RS-232 Cable, D-Shielded, 1.15m	Local
7	HDD	HITACHI	HDS728080PLA380	DoC	80GB	Local
8	HDD x3	HITACHI	HDS721032CLA362	DoC	320GB	Local

< EMS >

No.	Peripheral	Manufacturer	Model Number	FCC ID	Cable / Spec. Description	Placed
1	Personal Computer	DELL	T3500	DoC	N/A	Local
2	LCD Monitor	DELL	E1911F	DoC	D-SUB Cable, Shielded, 1.8m	Local
3	Keyboard	DELL	Y-003-DEL5	DoC	USB Cable, AL-F-Shielded, 2m	Local
4	Mouse	DELL	MS111-L	DoC	USB Cable, AL-F-Shielded, 1.8m	Local
5	1394B HDD	ONNTO	AT-S111	DoC	1394B Cable, D-Shielded, 1.8m	Local
6	HDD	HITACHI	HDS728080PLA380	DoC	80GB	Local
7	HDD x3	HITACHI	HDS721032CLA362	DoC	320GB	Local

4. Test Software

< EMI >

An executive program, "EMCTEST.exe" under WIN 7, which generates a complete line of continuously repeating "H" pattern was used as the test software.

The program was executed as follows:

- a. Turn on the power of all equipment.
- b. The PC reads the test program from the hard disk drive and runs it.
- c. The PC sends "H" pattern to the monitor, and the monitor displays "H" patterns on the screen.
- d. The PC sends "H" messages to the printer, and then the printer prints them on the paper.
- e. The PC sends signal messages to the modem.
- f. The PC sends signal messages to the internal Hard Disk, and the Hard Disk reads and writes the message.
- g. Repeat the steps from c to f.

At the same time, the following program was executed:

- Executed "Winthrax.exe" to read and write data from EUT.

< EMS >

During the test, the program under Win 7 was executed:

- Executed "Winthrax.exe" to read and write data from EUT.

5. General Information of Test

5.1. Test Facility

<EMI>

Test Site : SPORTON INTERNATIONAL INC.

Test Site Location : No. 3, Lane 238, Kang Lo Street, Nei Hwu District, Taipei 11424, Taiwan, R.O.C.

TEL : 886-2-2631-4739

FAX : 886-2-2631-9740

Test Site No. : CO01-NH, OS03-NH

Test Site Location : No. 52, Hwa Ya 1st Rd., Hwa Ya Technology Park, Kwei-Shan Hsiang, Tao Yuan Hsien, Taiwan, R.O.C.

TEL : 886-3-327-3456

FAX : 886-3-318-0055

Test Site No. : 03CH03-HY

<EMS>

Test Site Location : 3F, No.587, Tanmeu St., Neihsu District, Taipei, Taiwan, R.O.C.

TEL : 886-2-2794-8886

FAX : 886-2-2794-9777

5.2. Test Voltage

AC 230V / 50Hz

5.3. Measurement Procedure

EMI Test : European Standard EN 55022 Class B

Harmonics Test : European Standard EN 61000-3-2

Voltage Fluctuations Test : European Standard EN 61000-3-3

EMS Test : European Standard EN 55024

(ESD: IEC 61000-4-2, RS: IEC 61000-4-3, EFT: IEC 61000-4-4, SURGE: IEC 61000-4-5, CS: IEC 61000-4-6, Power Frequency Magnetic Field: IEC 61000-4-8, DIPS: IEC 61000-4-11)

5.4. Test in Compliance with

EMI Test : European Standard EN 55022 Class B

Harmonics Test : European Standard EN 61000-3-2

Voltage Fluctuations Test : European Standard EN 61000-3-3

EMS Test : European Standard EN 55024

(ESD: IEC 61000-4-2, RS: IEC 61000-4-3, EFT: IEC 61000-4-4, SURGE: IEC 61000-4-5, CS: IEC 61000-4-6, Power Frequency Magnetic Field: IEC 61000-4-8, DIPS: IEC 61000-4-11)

5.5. Frequency Range Investigated

- a. Conducted emission test: from 150 kHz to 30 MHz
- b. Radiated emission test: from 30 MHz to 6,000 MHz
- c. Radio frequency electromagnetic field immunity test: 80-1000 MHz

5.6. Test Distance

- a. The test distance of radiated emission test from antenna to EUT is 10 M (from 30MHz~1GHz).
- b. The test distance of radiated emission test from antenna to EUT is 3 M (from 1GHz~6GHz).
- c. The test distance of radio frequency electromagnetic field immunity test from antenna to EUT is 3 M.

6. Conducted Emissions Measurement

Conducted Emissions were measured from 150 kHz to 30 MHz with a bandwidth of 9 kHz and return leads of the EUT according to the methods defined in European Standard EN 55022 Clause 9. The EUT was placed on a nonmetallic stand in a shielded room 0.8 meter above the ground plane as shown in section 6.4. The interface cables and equipment positioning were varied within limits of reasonable applications to determine the position producing maximum conducted emissions.

6.1. Limits for conducted disturbance at mains terminals

Limits for conducted disturbance at mains terminals

Frequency range (MHz)	Class A Limits dB(μV)		Class B Limits dB(μV)	
	Quasi-peak	Average	Quasi-peak	Average
0.15 to 0.50	79	66	66 - 56	56 - 46
0.50 to 5	73	60	56	46
5 to 30	73	60	60	50

NOTE: The limits decrease linearly with the logarithm of the frequency in the range 0.15 MHz to 0.5 MHz.

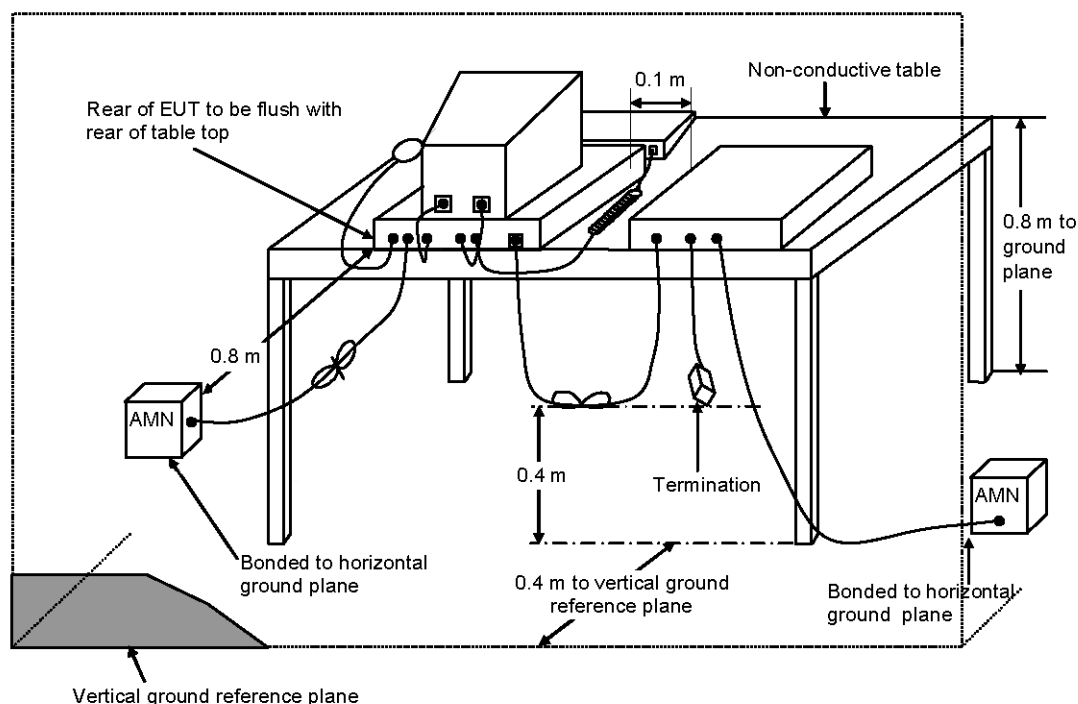
6.2. Description of Major Test Instruments

Test Receiver Parameters	Setting
Test Receiver	R&S ESCS 30
Attenuation	10 dB
Start Frequency	0.15 MHz
Stop Frequency	30 MHz
IF Bandwidth	9 kHz
Signal Input	9 kHz - 2.75 GHz

6.3. Test Procedures

- The EUT was placed on a desk 0.8 meter height from the metal ground plane and 0.4 meter from the conducting wall of the shielding room and it was kept at least 0.8 meter from any other grounded conducting surface.
- Connect EUT to the power mains through a line impedance stabilization network (LISN).
- All the support units are connect to the other LISN.
- The LISN provides 50 ohm, coupling impedance for the measuring instrument.
- The CISPR states that a 50 ohm, 50 microhenry LISN should be used.
- Both sides of AC line were checked for maximum conducted interference.
- The frequency range from 150 kHz to 30 MHz was searched.
- Set the test-receiver system to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.

6.4. Typical Test Setup Layout of AC Powerline Conducted Emissions



- a. AMN is 80 cm from the EUT and at least 80 cm from other units and other metal planes.
- b. EUT is connected to one artificial mains network (AMN).
- c. All other units of a system are powered from a second AMN. A multiple outlet strip can be used for multiple mains cords.
- d. Rear of EUT to be flushed with rear of table top.
- e. Peripherals shall be placed at a distance of 10 cm from each other and from the controller, except for the monitor which, if this is an acceptable installation practice, shall be placed directly on the top of the controller.
- f. If cables, which hang closer than 40 cm to the horizontal metal ground plane, cannot be shortened to appropriate length, the excess shall be folded back and forth forming a bundle 30 cm to 40 cm long.
- g. Mains cords and signal cables shall be positioned for their entire lengths, as far as possible, at 40 cm from the vertical reference plane.
- h. Cables of hand operated devices, such as keyboards, mice, etc. shall be placed as for normal usage.

6.5. Test Result of AC Powerline Conducted Emission

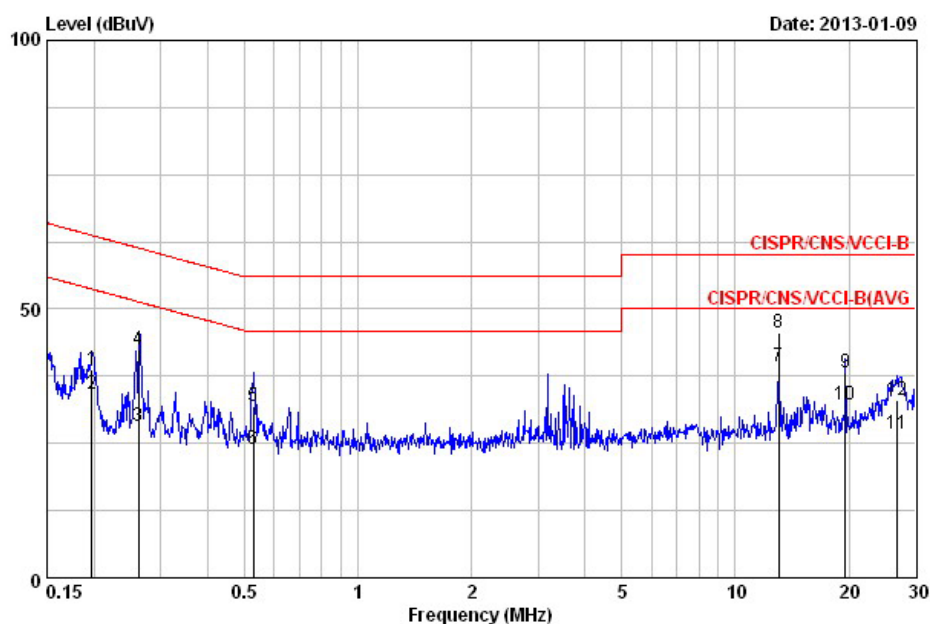
Test Mode	Mode 1	Test Site No.	CO01-NH
Test Frequency	0.15 MHz ~ 30 MHz	Test Engineer	Willy
Temperature	20 °C	Relative Humidity	52 %

Note: 1. Corrected Reading (dB μ V) = LISN Factor + Cable Loss + Read Level = Level

2. All emissions not reported here are more than 10 dB below the prescribed limit.

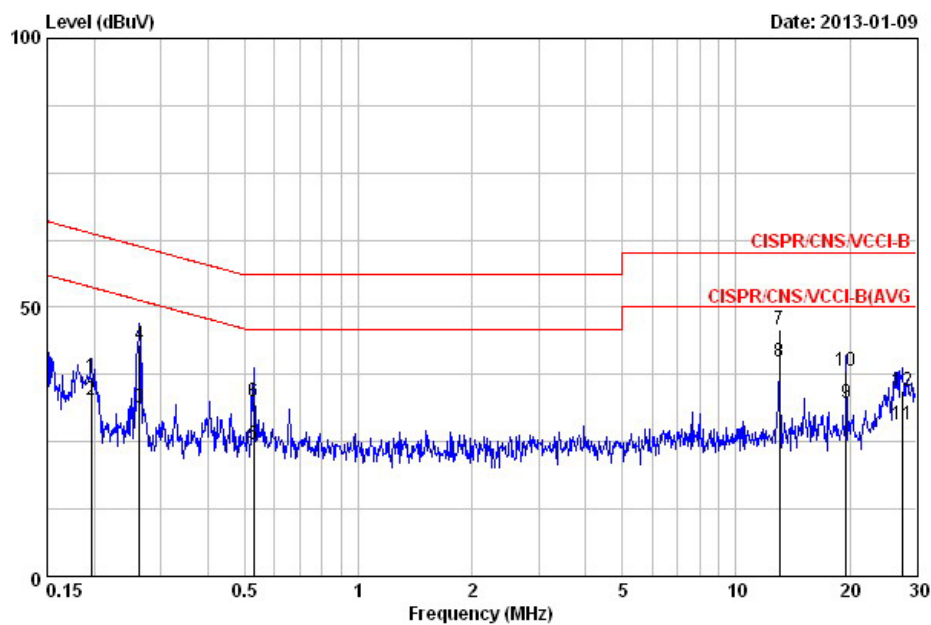
■ The test was passed at the minimum margin that marked by the frame in the following data

Line



	Freq	Level	Over Limit	Limit Line	Read Level	LISN Factor	Cable Loss	Remark
	MHz	dB μ V	dB	dB μ V	dB μ V	dB	dB	
1	0.198	38.65	-25.07	63.71	28.38	10.17	0.10	QP
2	0.198	34.25	-19.47	53.71	23.98	10.17	0.10	AVERAGE
3	0.262	28.32	-23.06	51.38	18.05	10.17	0.10	AVERAGE
4	0.262	42.51	-18.87	61.38	32.24	10.17	0.10	QP
5	0.529	31.92	-24.08	56.00	21.64	10.18	0.10	QP
6	0.529	24.03	-21.97	46.00	13.75	10.18	0.10	AVERAGE
7	13.002	39.30	-10.70	50.00	28.73	10.37	0.20	AVERAGE
8	13.002	45.45	-14.55	60.00	34.88	10.37	0.20	QP
9	19.532	38.21	-21.79	60.00	27.46	10.46	0.29	QP
10	19.532	32.16	-17.84	50.00	21.41	10.46	0.29	AVERAGE
11	26.699	26.80	-23.20	50.00	15.85	10.55	0.40	AVERAGE
12	26.699	33.03	-26.97	60.00	22.08	10.55	0.40	QP

Neutral



	Freq	Level	Over	Limit	Read	LISN	Cable	Remark
	MHz	dBuV	Limit	Line	Level	Factor	Loss	
			dB	dBuV	dBuV	dB	dB	
1	0.197	37.16	-26.59	63.76	26.92	10.14	0.10	QP
2	0.197	32.73	-21.02	53.76	22.49	10.14	0.10	AVERAGE
3	0.263	31.21	-20.12	51.34	20.97	10.14	0.10	AVERAGE
4	0.263	42.98	-18.35	61.34	32.74	10.14	0.10	QP
5	0.529	24.43	-21.57	46.00	14.19	10.14	0.10	AVERAGE
6	0.529	32.36	-23.64	56.00	22.12	10.14	0.10	QP
7	13.003	46.00	-14.00	60.00	35.45	10.35	0.20	QP
8	13.003	39.87	-10.13	50.00	29.32	10.35	0.20	AVERAGE
9	19.532	32.20	-17.80	50.00	21.46	10.45	0.29	AVERAGE
10	19.532	38.30	-21.70	60.00	27.56	10.45	0.29	QP
11	27.708	28.07	-21.93	50.00	17.08	10.59	0.40	AVERAGE
12	27.708	34.58	-25.42	60.00	23.59	10.59	0.40	QP

7. Radiated Emission Measurement

Radiated emissions from 30 MHz to 6,000 MHz were measured with a bandwidth of 120 kHz for 30 MHz to 1,000 MHz and 1 MHz for above 1GHz according to the methods defines in European Standard EN 55022, Clause 10. The EUT was placed on a nonmetallic stand, 0.8 meter above the ground plane, as shown in section 7.4. The interface cables and equipment positions were varied within limits of reasonable applications to determine the positions producing maximum radiated emissions.

7.1. Limits for radiated disturbance

Limits for radiated disturbance at a measuring distance of 10 m

Frequency range (MHz)	Class A	Class B
	Quasi-peak limits dB(μV/m)	Quasi-peak limits dB(μV/m)
30 to 230	40	30
230 to 1000	47	37

Limits for radiated disturbance at a measuring distance of 3 m

Frequency range (MHz)	Class A		Class B	
	Average limit dB(μV/m)	Peak limit dB(μV/m)	Average limit dB(μV/m)	Peak limit dB(μV/m)
1000 to 3000	56	76	50	70
3000 to 6000	60	80	54	74

7.2. Description of Major Test Instruments

For Below 1GHz

Amplifier Parameters	Setting
Amplifier	HP 8447D
RF Gain	25 dB
Signal Input	0.1 MHz - 1.3 GHz

Spectrum Analyzer Parameters	Setting
Spectrum Analyzer	ADVANTEST R3261C
Attenuation	10 dB
Start Frequency	30 MHz
Stop Frequency	1000 MHz
Resolution Bandwidth	120 kHz
Signal Input	9 kHz – 2.6 GHz

Test Receiver Parameters	Setting
Test Receiver	R&S ESCS 30
Resolution Bandwidth	120 kHz
Frequency Band	9 kHz - 2.75 GHz
Quasi-Peak Detector	ON for Quasi-Peak Mode
	OFF for Peak Mode

For above 1GHz

Amplifier Parameters	Setting
Amplifier	Agilent 8449B
RF Gain	35 dB
Signal Input	1 GHz - 26.5 GHz

Test Receiver Parameters	Setting
Test Receiver	R&S FSP30
Attenuation	10 dB
Start Frequency	1000 MHz
Stop Frequency	6000 MHz
Resolution Bandwidth	1 MHz
Signal Input	9kHz ~ 30GHz

7.3. Test Procedures

For Below 1GHz

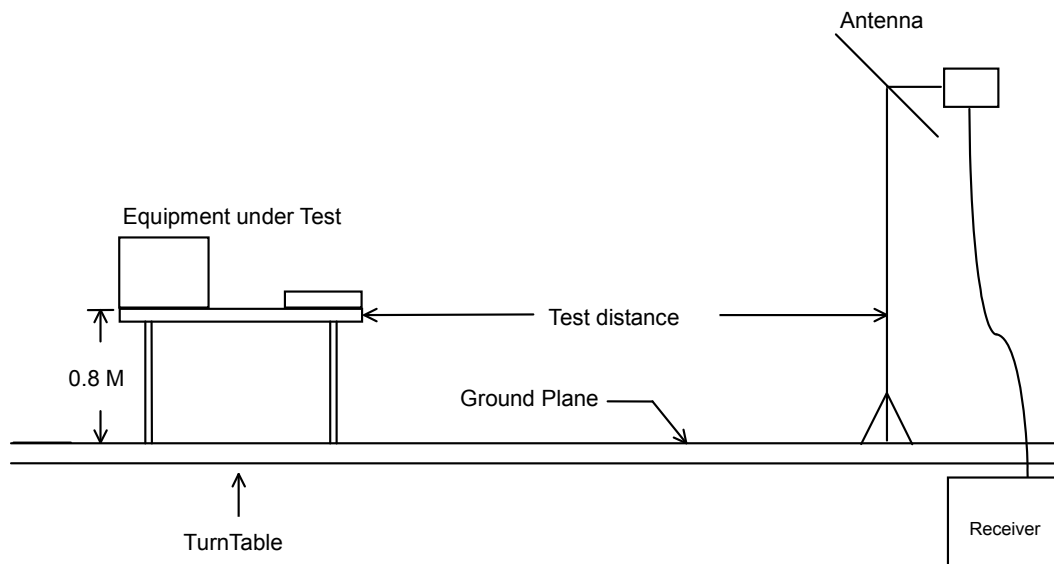
- a. The EUT was placed on a rotatable table top 0.8 meter above ground.
- b. The EUT was set 10 meters from the interference-receiving antenna which was mounted on the top of a variable height antenna tower.
- c. The table was rotated 360 degrees to determine the position of the highest radiation.
- d. The antenna is a half wave dipole and its height is varied between one meter and four meters above ground to find the maximum value of the field strength both horizontal polarization and vertical polarization of the antenna are set to make the measurement.
- e. For each suspected emission the EUT was arranged to its worst case and then tune the antenna tower (from 1 M to 4 M) and turn table (from 0 degree to 360 degrees) to find the maximum reading.
- f. Set the test-receiver system to Peak Detect Function and specified bandwidth with Maximum Hold Mode.
- g. If the emission level of the EUT in peak mode was 3 dB lower than the limit specified, then testing will be stopped and peak values of EUT will be reported, otherwise, the emissions which do not have 3 dB margin will be repeated one by one using the quasi-peak method and reported.

For above 1GHz

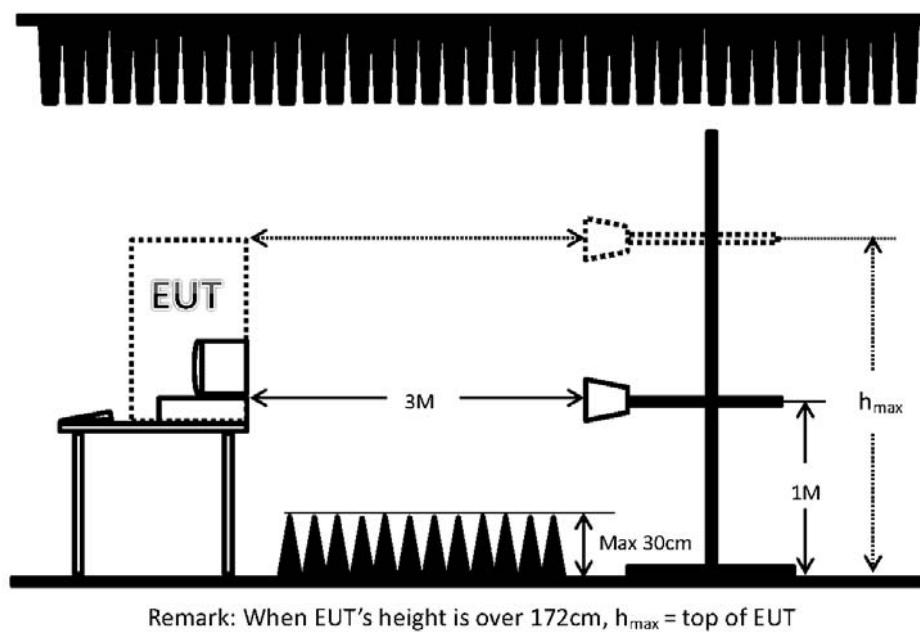
- a. Same test set up as below 1GHz radiated testing.
- b. The EUT was set 3 meters from the interference-receiving antenna which was mounted on the top of a variable height antenna tower.
- c. There should be absorber placed between the EUT and Antenna and its located size should let the test site meet CISPR16-1-4 requirement.
- d. The table was rotated 360 degrees to determine the position of the highest radiation.
- e. Set the test-receiver system to Peak Detect Function and specified bandwidth with Maximum Hold Mode.
- f. Set the DRG Horn Antenna (Model: 3115) at 1M height, then run the turn table to get the maximum noise reading from Horizontal and Vertical polarity separately.
- g. When EUT locating on the turn-table, and its height is over 172cm (Antenna's 3dB beam width of 6GHz is 27°), the DRG Horn Antenna must be raised up and descended down, then turning around the turn-table to get the maximum noise reading of the Horizontal and Vertical polarity separately. Note the maximum raise up height is same as the top of EUT.
- h. If emission level of the EUT in peak mode was 20dB lower than average limit (that means the emission level in peak mode also complies with the limit in average mode), then testing will be stopped and peak values of EUT will be reported, otherwise, the emissions will be measured in average mode again and reported.

7.4. Typical Test Setup Layout of Radiated Emissions

For Below 1GHz



For above 1GHz



7.5. Test Result of Radiated Emission for Below 1GHz

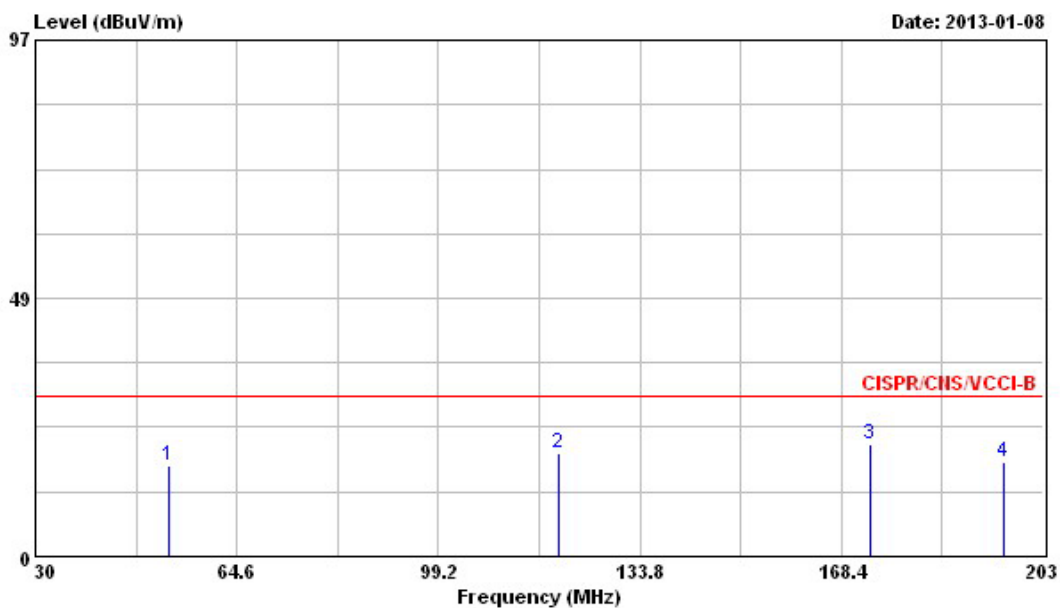
Test mode	Mode 1	Test Site No.	OS03-NH
Test frequency	30 MHz ~ 1000 MHz	Test Engineer	Alan
Temperature	18 °C	Relative Humidity	56 %

Note: 1. Emission level (dB μ V/m) = 20 log Emission level (μ V/m)

2. Corrected Reading : Antenna Factor + Cable Loss + Read Level – Preamp Factor = Level

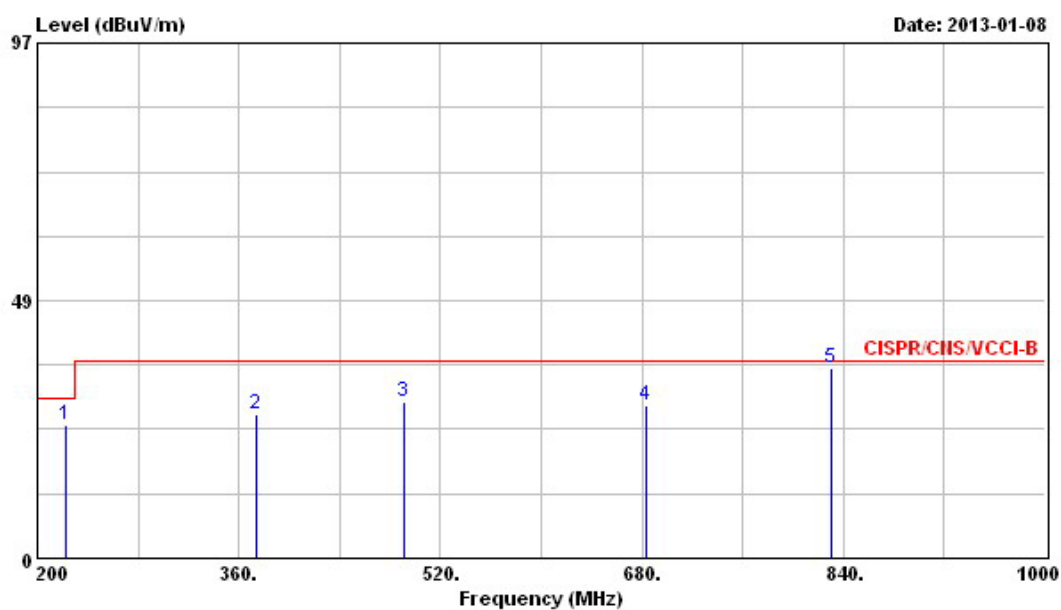
■ The test was passed at the minimum margin that marked by the frame in the following data

Vertical



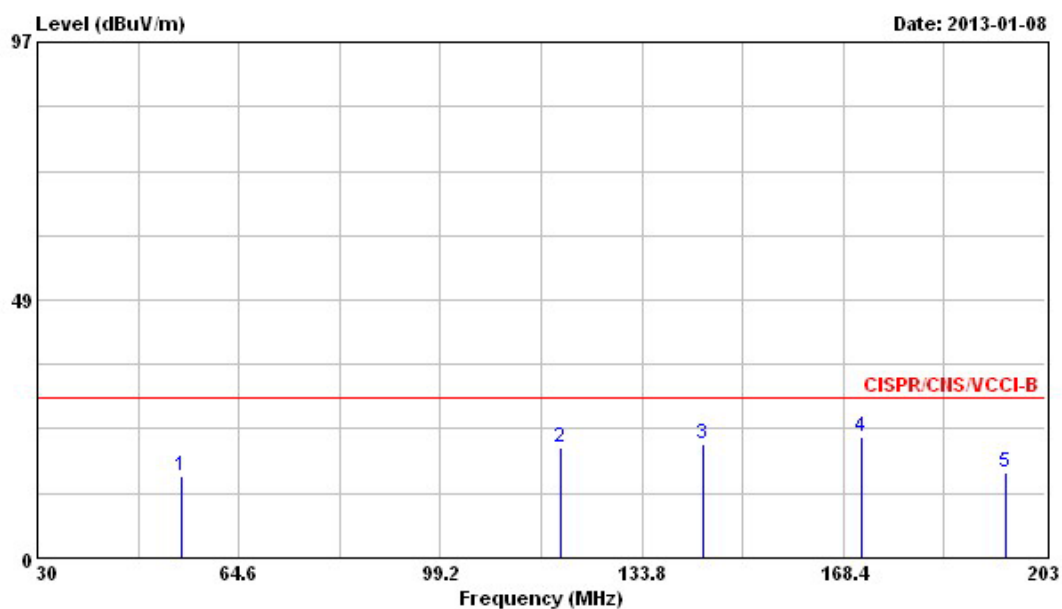
	Freq	Level	Over	Limit	Read	Antenna	Cable	Preamp		Ant	Table
	MHz	dB μ V/m	Limit	Line	Level	Factor	Loss	Factor	Remark	Pos	Pos
			dB	dB μ V/m	dB μ V	dB/m	dB	dB		cm	deg
1	53.010	17.11	-12.89	30.00	36.36	8.08	1.12	28.45	Peak	---	---
2	119.790	19.37	-10.63	30.00	33.50	12.28	1.85	28.26	Peak	---	---
3	173.240	21.08	-8.92	30.00	37.40	9.41	2.34	28.07	Peak	---	---
4	196.250	17.64	-12.36	30.00	33.81	9.20	2.61	27.98	Peak	---	---

Vertical



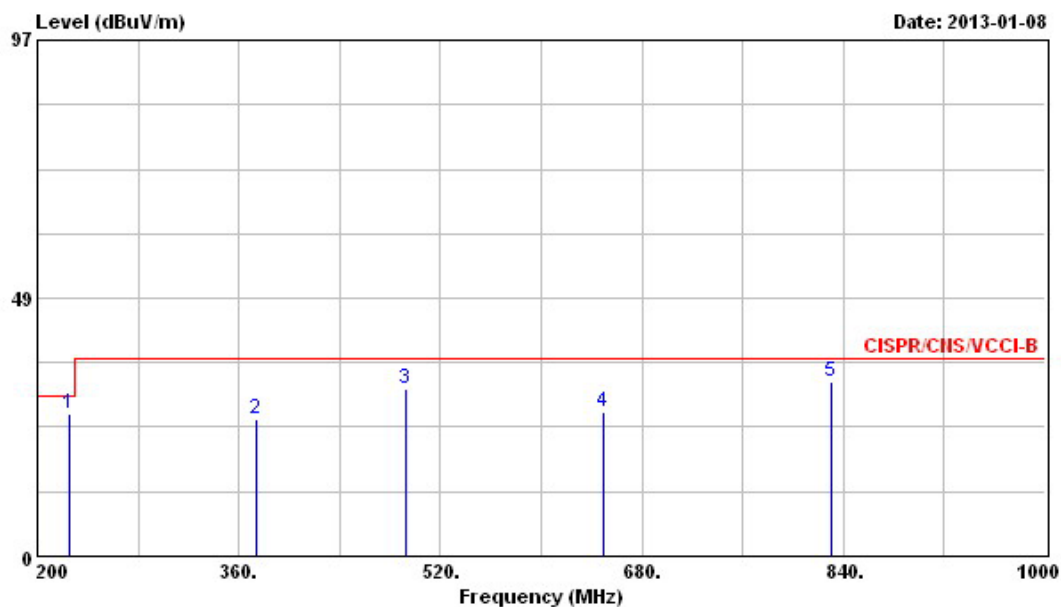
	Freq	Level	Over	Limit	Read	Antenna	Cable	Preamp		Ant	Table
	MHz	dBuV/m	Limit	Line	Level	Factor	Loss	Factor	Remark	Pos	Pos
	MHz	dBuV/m	dB	dBuV/m	dBuV	dB/m	dB	dB		cm	deg
1	222.400	25.07	-4.93	30.00	39.64	10.58	2.79	27.94	Peak	---	---
2	374.400	27.19	-9.81	37.00	35.80	15.07	4.63	28.31	Peak	---	---
3	491.200	29.54	-7.46	37.00	36.00	17.22	5.31	28.99	Peak	---	---
4	684.000	28.83	-8.17	37.00	34.00	18.74	5.25	29.16	Peak	---	---
5	830.400	35.92	-1.08	37.00	39.30	19.82	5.63	28.83	QP	200	180

Horizontal



	Freq	Level	Over	Limit	ReadAntenna	Cable	Preamp		Ant	Table
	MHz	dBuV/m	Limit	Line	Level	Factor	Loss	Factor	Pos	Pos
	MHz	dBuV/m	dB	dBuV/m	dBuV	dB/m	dB	dB	cm	deg
1	54.740	15.34	-14.66	30.00	35.01	7.63	1.15	28.45	Peak	---
2	119.790	20.67	-9.33	30.00	34.80	12.28	1.85	28.26	Peak	---
3	144.350	21.50	-8.50	30.00	36.78	10.82	2.07	28.17	Peak	---
4	171.510	22.72	-7.28	30.00	38.99	9.48	2.32	28.07	Peak	---
5	196.250	16.04	-13.96	30.00	32.21	9.20	2.61	27.98	Peak	---

Horizontal



	Freq	Level	Over	Limit	ReadAntenna	Cable	Preamp		Ant	Table
	MHz	dBuV/m	Limit	Line	Level	Factor	Loss	Factor	Pos	Pos
	MHz	dBuV/m	dB	dBuV/m	dBuV	dB/m	dB	dB	cm	deg
1	224.800	26.65	-3.35	30.00	40.99	10.76	2.83	27.93	Peak	---
2	374.400	25.59	-11.41	37.00	34.20	15.07	4.63	28.31	Peak	---
3	492.800	31.54	-5.46	37.00	38.00	17.25	5.29	29.00	Peak	---
4	648.800	27.05	-9.95	37.00	32.39	18.63	5.22	29.19	Peak	---
5	830.400	32.82	-4.18	37.00	36.20	19.82	5.63	28.83	Peak	---

7.6. Test Result of Radiated Emission for Above 1GHz

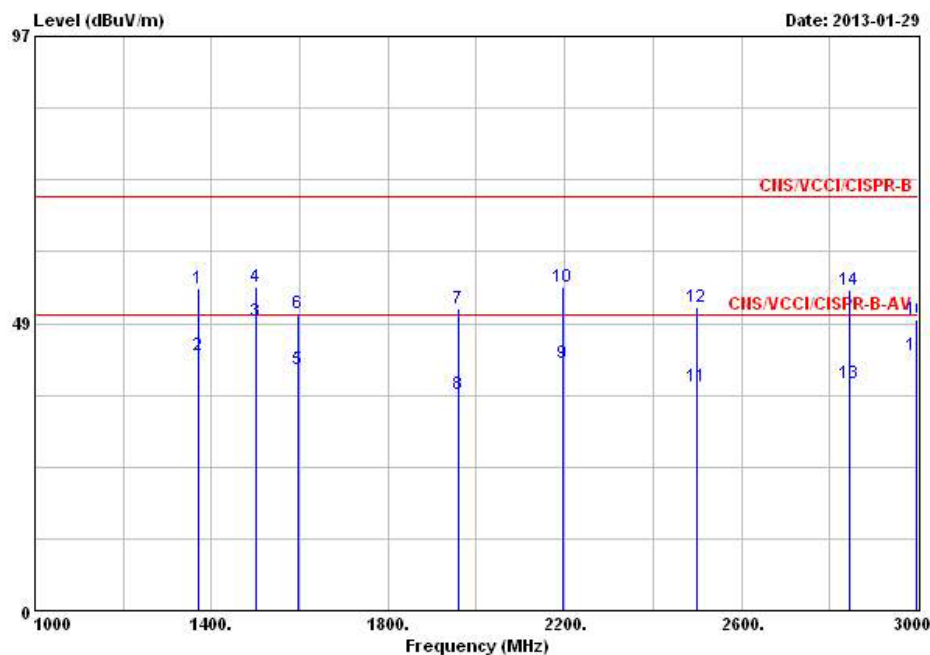
Test mode	Mode 3	Test Site No.	03CH03-HY
Test frequency	1 GHz ~ 6 GHz	Test Engineer	Alan Chen
Temperature	22 °C	Relative Humidity	55 %

Note: 1. Emission level (dBμV/m) = 20 log Emission level (μV/m)

2. Corrected Reading : Antenna Factor + Cable Loss + Read Level – Preamp Factor = Level

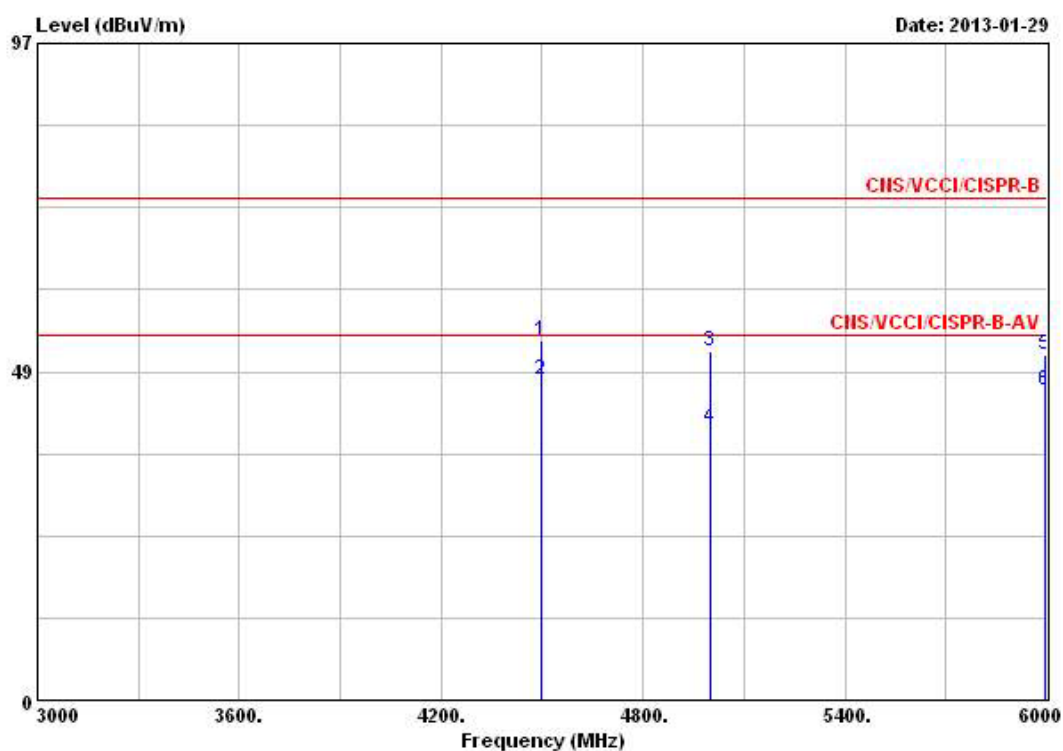
■ The test was passed at the minimum margin that marked by the frame in the following data

Vertical



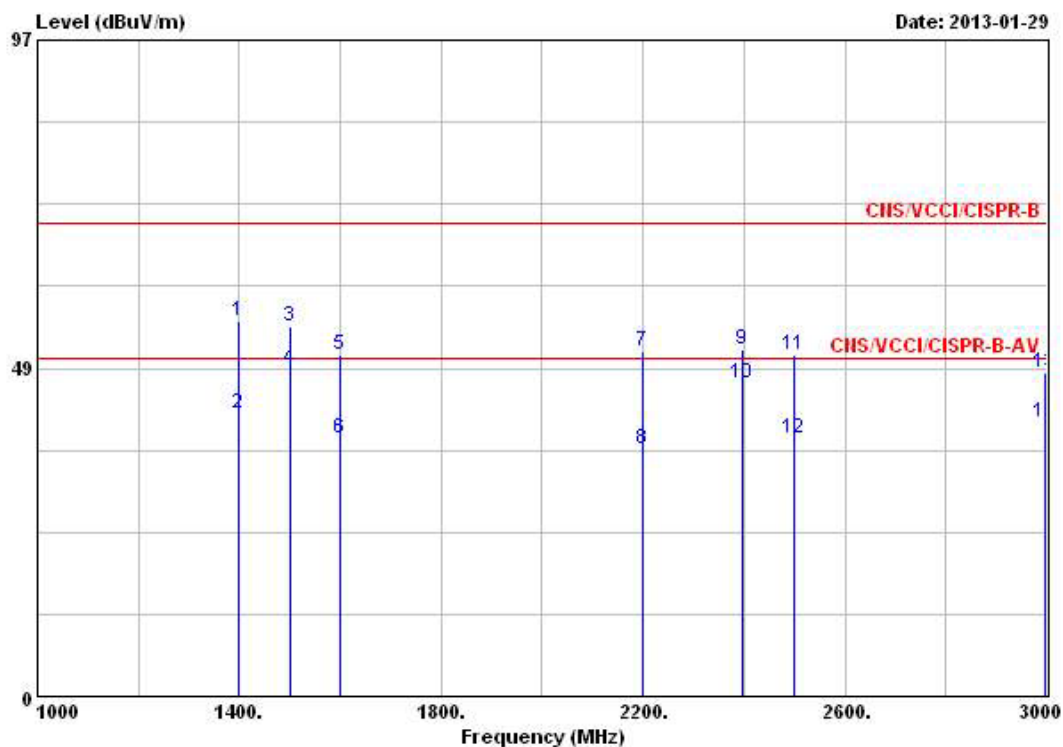
	Freq	Level	Over Limit	Limit Line	ReadAntenna Level	Antenna Factor	Cable Loss	Preamp Factor	Remark	Ant Pos	Table Pos
	MHz	dBμV/m	dB	dBμV/m	dBμV	dB/m	dB	dB		cm	deg
1	1372.000	54.30	-15.70	70.00	59.22	24.88	3.46	33.26	Peak	---	---
2	1372.000	43.16	-6.84	50.00	48.08	24.88	3.46	33.26	Average	100	180
3	1500.000	48.83	-1.17	50.00	52.83	25.10	3.88	32.98	Average	100	0
4	1500.000	54.70	-15.30	70.00	58.70	25.10	3.88	32.98	Peak	---	---
5	1596.000	40.71	-9.29	50.00	44.21	25.52	3.91	32.93	Average	100	220
6	1596.000	50.27	-19.73	70.00	53.77	25.52	3.91	32.93	Peak	---	---
7	1958.000	51.03	-18.97	70.00	52.65	26.99	4.06	32.67	Peak	---	---
8	1958.000	36.51	-13.49	50.00	38.13	26.99	4.06	32.67	Average	100	178
9	2196.000	41.91	-8.09	50.00	42.69	27.54	4.36	32.68	Average	100	178
10	2196.000	54.77	-15.23	70.00	55.55	27.54	4.36	32.68	Peak	---	---
11	2500.000	37.90	-12.10	50.00	37.76	28.10	4.77	32.73	Average	100	208
12	2500.000	51.37	-18.63	70.00	51.23	28.10	4.77	32.73	Peak	---	---
13	2844.000	38.35	-11.65	50.00	36.67	29.23	5.23	32.78	Average	100	0
14	2844.000	54.20	-15.80	70.00	52.52	29.23	5.23	32.78	Peak	---	---
15	2998.000	43.04	-6.96	50.00	40.61	29.80	5.44	32.81	Average	100	150
16	2998.000	49.06	-20.94	70.00	46.63	29.80	5.44	32.81	Peak	---	---

Vertical



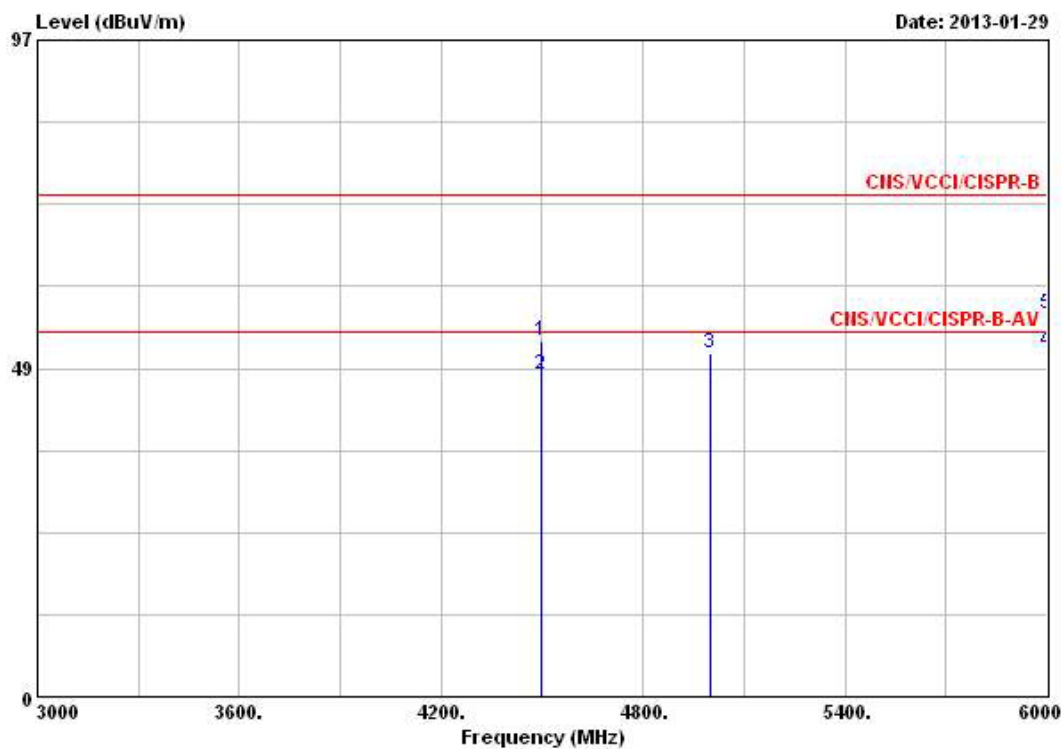
	Freq	Level	Over Limit	Limit Line	ReadAntenna Level	Antenna Factor	Cable Loss	Preamp Factor	Remark	Ant Pos	Table Pos
	MHz	dBuV/m	dB	dBuV/m	dBuV	dB/m	dB	dB		cm	deg
1	4497.000	52.99	-21.01	74.00	47.97	32.20	5.49	32.67	Peak	---	---
2	4497.000	47.29	-6.71	54.00	42.27	32.20	5.49	32.67	Average	100	190
3	4998.000	51.41	-22.59	74.00	45.48	33.10	5.40	32.57	Peak	---	---
4	4998.000	40.24	-13.76	54.00	34.31	33.10	5.40	32.57	Average	100	212
5	5997.000	51.05	-22.95	74.00	44.57	34.00	5.08	32.60	Peak	---	---
6	5997.000	45.86	-8.14	54.00	39.38	34.00	5.08	32.60	Average	100	175

Horizontal



	Freq	Level	Over Limit	Limit Line	ReadAntenna Level	Antenna Factor	Cable Loss	Preamp Factor	Remark	Ant Pos	Table Pos
	MHz	dBuV/m	dB	dBuV/m	dBuV	dB/m	dB	dB		cm	deg
1	1398.000	55.44	-14.56	70.00	60.27	24.91	3.46	33.20	Peak	---	---
2	1398.000	41.71	-8.29	50.00	46.54	24.91	3.46	33.20	Average	100	138
3	1500.000	54.57	-15.43	70.00	58.57	25.10	3.88	32.98	Peak	---	---
4	1500.000	48.29	-1.71	50.00	52.29	25.10	3.88	32.98	Average	100	166
5	1598.000	50.48	-19.52	70.00	53.98	25.52	3.91	32.93	Peak	---	---
6	1598.000	38.08	-11.92	50.00	41.58	25.52	3.91	32.93	Average	100	223
7	2198.000	51.00	-19.00	70.00	51.78	27.54	4.36	32.68	Peak	---	---
8	2198.000	36.45	-13.55	50.00	37.23	27.54	4.36	32.68	Average	100	135
9	2398.000	51.36	-18.64	70.00	51.51	27.91	4.65	32.71	Peak	---	---
10	2398.000	46.27	-3.73	50.00	46.42	27.91	4.65	32.71	Average	100	149
11	2500.000	50.53	-19.47	70.00	50.39	28.10	4.77	32.73	Peak	---	---
12	2500.000	37.99	-12.01	50.00	37.85	28.10	4.77	32.73	Average	100	142
13	2998.000	47.74	-22.26	70.00	45.31	29.80	5.44	32.81	Peak	---	---
14	2998.000	40.36	-9.64	50.00	37.93	29.80	5.44	32.81	Average	100	219

Horizontal



	Freq	Level	Over Limit	Limit Line	ReadAntenna Level	Antenna Factor	Cable Loss	Preamp Factor	Remark	Ant Pos	Table Pos
	MHz	dBuV/m	dB	dBuV/m	dBuV	dB/m	dB	dB		cm	deg
1	4497.000	52.48	-21.52	74.00	47.46	32.20	5.49	32.67	Peak	---	---
2	4497.000	47.68	-6.32	54.00	42.66	32.20	5.49	32.67	Average	100	113
3	4998.000	50.68	-23.32	74.00	44.75	33.10	5.40	32.57	Peak	---	---
4	6000.000	51.08	-2.92	54.00	44.60	34.00	5.08	32.60	Average	100	200
5	6000.000	56.44	-17.56	74.00	49.96	34.00	5.08	32.60	Peak	---	---

8. Harmonic Current Emissions Measurement

As specified on clause 7 of EN 61000-3-2:2006/A1:2009/A2:2009, the limits are not specified for equipment with a rated power of 75W or less.

The EUT meets the above condition, so it conforms to EN 61000-3-2.

9. Voltage Fluctuations and Flicker Measurement

9.1. Standard

- Product Standard : EN 61000-3-3:2008

9.2. Test Procedure

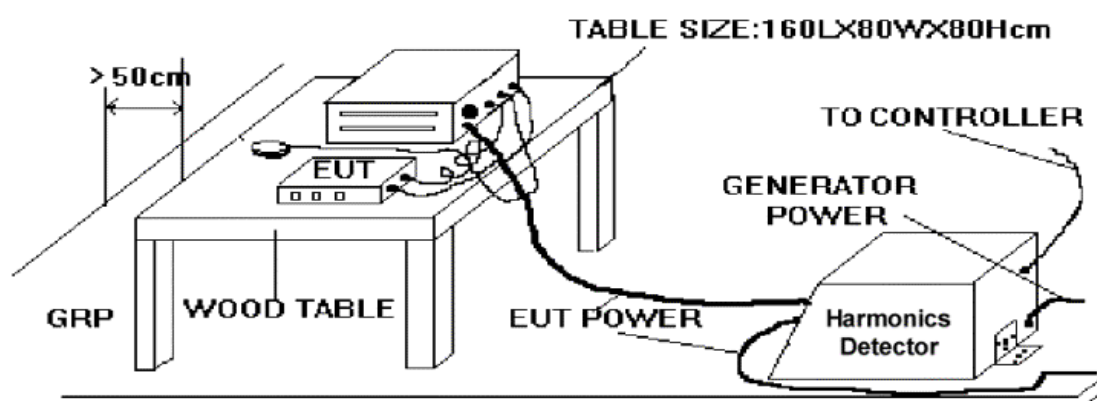
The equipment shall be tested under the conditions of **Clause 5**.

The total impedance of the test circuit, excluding the appliance under test, but including the internal impedance of the supply source, shall be equal to the reference impedance. The stability and tolerance of the reference impedance shall be adequate to ensure that the overall accuracy of $\pm 8\%$ is achieved during the whole assessment procedure.

9.3. Test Equipment Settings

Flicker Parameters	Setting
Line Voltage	230 V
Line Frequency	50 Hz
Measurement Delay	10.0 seconds
Pst Integration Time	10.0 minutes
Pst Integration Periods	1
Test Duration	10.0 minutes

9.4. Typical Test Setup Layout of Voltage Fluctuations and Flicker



9.5. Test Result of Voltage Fluctuation and Flicker

Test mode	Mode 1		
Temperature	22 °C	Final Test Result	<u>PASS</u>
Relative Humidity	48 %	Test Date	Mar. 15, 2013
Atmospheric Pressure	102 kPa	Test Engineer	Yen-Liang

Urms = 230.1V Freq = 49.987 Range: 1 A
 Irms = 0.274A Ipk = 0.462A cf = 1.688
 P = 51.93W S = 63.03VA pf = 0.824

Test - Time : 1 x 10min = 10min (100 %)

LIN (Line Impedance Network) : SLIN 0.24ohm +j0.15ohm N:0.16ohm +j0.10ohm

Limits : Plt : 0.65 Pst : 1.00
 dmax : 4.00 % dc : 3.30 %
 dtLim: 3.30 % dt>Lim: 500ms

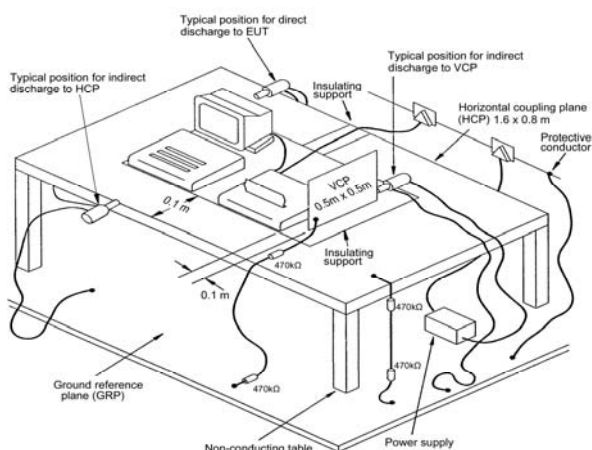
Test completed, Result: PASSED

	Pst	P50s	P10s	P3s	P1s	P0.1s	dmax	dc	dt>Lim
1	0.072	0.010	0.010	0.010	0.010	0.010	0.000	0.010	0.000

10. Electrostatic Discharge Immunity Measurement (ESD)

- Final Test Result : **PASS**
- Pass Performance Criteria : **B**
- Required Performance Criteria : B
- Basic Standard : IEC 61000-4-2:2008
- Product Standard : EN 55024:2010
- Level : 3 for air discharge
2 for contact discharge
- Test Voltage : $\pm 2 / \pm 4 / \pm 8$ kV for air discharge
 $\pm 2 / \pm 4$ kV for contact discharge
- Discharge Impedance : 330 ohm / 150 pF
- Temperature : 22 °C
- Relative Humidity : 44 %
- Atmospheric Pressure : 102 kPa
- Test Date : Mar. 14, 2013
- Test Engineer : Yen-Liang
- Observation : When testing at contact discharge ± 4 kV on case, screw & bracket, the function of R/W was disconnected caused by interference. After the test, the equipment continued to operate as intended without operator intervention.

10.1. Test Setup



The test setup consists of the test generator, EUT and auxiliary instrumentation necessary to perform DIRECT and INDIRECT application of discharges to the EUT as applicable, in the follow manner:

- a. CONTACT DISCHARGE to the conductive surfaces and to coupling plane;
- b. AIR DISCHARGE at insulating surfaces.

The preferred test method is that of type tests performed in laboratories and the only accepted method of demonstrating conformance with this standard. The EUT was arranged as closely as possible to arrangement in final installed conditions.

10.2. Test Setup for Tests Performed in Laboratory

A ground reference plane was provided on the floor of the test site. It was a metallic sheet (copper or aluminum) of 0.25 mm, minimum thickness; other metallic may be used but they shall have at least 0.65 mm thickness. In the SPORTON EMC LAB., we provided 1 mm thickness aluminum ground reference plane or 1 mm thickness stainless steel ground reference plane. The minimum size of the ground reference plane is 1 m x 1 m, the exact size depending on the dimensions of the EUT. It was connected to the protective grounding system.

The EUT was arranged and connected according to its functional requirements. A distance of 1 m minimum was provided between the EUT and the wall of the Lab., and any other metallic structure. In cases where this length exceeds the length necessary to apply the discharges to the selected points, the excess length shall, where possible, be placed non-inductively off the ground reference plane and shall not come closer than 0.2 m to other conductive parts in the test setup.

Where the EUT is installed on a metal table, the table was connected to the reference plane via a cable with a 470k ohm resistor located at each end, to prevent a build-up of charge. The test setup was consist a wooden table, 0.8 m high, standing on the ground reference plane. A HCP, 1.6 m x 0.8 m, was placed on the table. The EUT and cables was isolated from the HCP by an insulating support 0.5 mm thick. The VCP size, 0.5 m x 0.5 m.

10.3. ESD Test Procedure

- a. In the case of air discharge testing the climatic conditions shall be within the following ranges:
 - ambient temperature: 15 °C to 35 °C;
 - relative humidity : 30 % to 60 %;
 - atmospheric pressure : 86 kPa (860 mbar) to 106 kPa (1060 mbar).
- b. Test programs and software shall be chosen so as to exercise all normal modes of operation of the EUT. The use of special exercising software is encouraged, but permitted only where it can be shown that the EUT is being comprehensively exercised.
- c. The test voltage shall be increased from the minimum to the selected test severity level, in order to determine any threshold of failure. The final severity level should not exceed the product specification value in order to avoid damage to the equipment.
- d. The test shall be performed with both air discharge and contact discharge. On preselected points at least 10 single discharges (in the most sensitive polarity) shall be applied on air discharge. On preselected points at least 25 single discharges (in the most sensitive polarity) shall be applied on contact discharge.
- e. For the time interval between successive single discharges an initial value of one second is recommended. Longer intervals may be necessary to determine whether a system failure has occurred.
- f. In the case of contact discharges, the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.
- g. In the case of painted surface covering a conducting substrate, the following procedure shall be adopted:
 - If the coating is not declared to be an insulating coating by the equipment manufacturer, then the pointed tip of the generator shall penetrate the coating so as to make contact with the conducting substrate.
 - Coating declared as insulating by the manufacturer shall only be submitted to the air discharge.
 - The contact discharge test shall not be applied to such surfaces.
- h. In the case of air discharges, the round discharge tip of the discharge electrode shall be approached as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator (discharge electrode) shall be removed from the EUT. The generator is then retriggered for a new single discharge. This procedure shall be repeated until the discharges are completed. In the case of an air discharge test, the discharge switch, which is used for contact discharge, shall be closed.

10.4. Test Severity Levels

10.4.1. Contact Discharge

Level	Test Voltage (KV) of Contact discharge
1	± 2
2	± 4
3	± 6
4	± 8
X	Specified
Remark : "X" is an open level.	

10.4.2. Air Discharge

Level	Test Voltage (KV) of Air Discharge
1	± 2
2	± 4
3	± 8
4	± 15
X	Specified
Remark : "X" is an open level.	

10.5. Test Points

10.5.1. Test Result of Air Discharge

Test Method	No. of Discharges	Air Discharge/Round Tip						Test Record
		+2kV	-2kV	+4kV	-4kV	-8kV	+8kV	
Power Switching	10	ND	ND	ND	ND	ND	ND	Note ¹
LED	10	ND	ND	ND	ND	ND	ND	Note ¹
AC Socket	10	ND	ND	ND	ND	ND	ND	Note ¹
e-SATA Port	10	ND	ND	ND	ND	ND	ND	Note ¹
Panel	10	ND	ND	ND	ND	ND	ND	Note ¹
1394B Port	10	ND	ND	ND	ND	ND	ND	Note ¹
Remark	Note ¹ . The "ND" is means No Discharge.							

10.5.2. Test Result of Contact Discharge

Direct discharge

Test Method	No. of Discharges	Contact Discharge/Pointed Tip				Test Record
		+2kV	-2kV	+4kV	-4kV	
Case	25	A	A	B	B	Note ¹
Screw	25	A	A	B	B	Note ¹
Bracket	25	A	A	B	B	Note ¹
USB PORT	25	A	A	A	A	None
Remark	Note 1. When testing at contact discharge $\pm 4\text{kV}$ on case 、 screw & bracket, the function of R/W was disconnected caused by interference. After the test, the equipment continued to operate as intended without operator intervention.					

Indirect discharge to HCP and VCP

Test Method	No. of Discharges	Contact Discharge/Pointed Tip				Test Record
		+2kV	-2kV	+4kV	-4kV	
HCP (At Front)	25	A	A	A	A	None
HCP (At Left)	25	A	A	A	A	None
HCP (At Right)	25	A	A	A	A	None
HCP (At Rear)	25	A	A	A	A	None
VCP (At Front)	25	A	A	A	A	None
VCP (At Left)	25	A	A	A	A	None
VCP (At Right)	25	A	A	A	A	None
VCP (At Rear)	25	A	A	A	A	None

11. Radio Frequency Electromagnetic Field Immunity Measurement (RS)

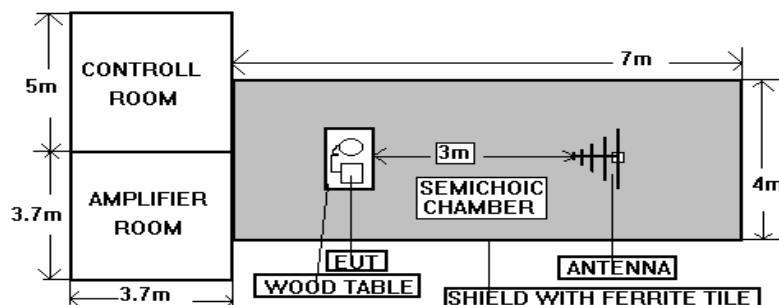
- Final Test Result : **PASS**
- Pass Performance Criteria : **A**
- Required Performance Criteria : A
- Basic Standard : IEC 61000-4-3:2006/A1:2007/A2:2010
- Product Standard : EN 55024:2010
- Level : 2
- Frequency Range : 80-1000 MHz
- Additional Selection Frequency : 80, 120, 160, 230, 434, 460, 600, 863, 900MHz
- Dwell Time : 2.9 seconds
- Frequency Step size : 1 % of the preceding frequency value
- Field Strength : 3 V/m (unmodulated, r.m.s) 80% AM (1 kHz)
- Temperature : 22 °C
- Relative Humidity : 48 %
- Atmospheric Pressure : 102 kPa
- Test Date : Mar. 15, 2013
- Test Engineer : Yen-Liang

11.1. Test Record

Frequency Band: 80-1000 MHz

Sides of the EUT have been exposed to the field	Antenna positioned	Test field strength Level	Test field strength (V/m)	Observation
Front	Vertical	2	3	Normal (No influencing)
	Horizontally	2	3	Normal (No influencing)
Left	Vertical	2	3	Normal (No influencing)
	Horizontally	2	3	Normal (No influencing)
Back	Vertical	2	3	Normal (No influencing)
	Horizontally	2	3	Normal (No influencing)
Right	Vertical	2	3	Normal (No influencing)
	Horizontally	2	3	Normal (No influencing)

11.2. Test Setup



NOTE : The SPORTON 7m x 4m x 4m semi-anechoic chamber is compliance with the sixteen point's uniform field requirement as stated in IEC 61000-4-3 Section 6.2.

The procedure defined in this part requires the generation of electromagnetic fields within which the test sample is placed and its operation observed. To generate fields that are useful for simulation of actual (field) conditions may require significant antenna drive power and the resultant high field strength levels. To comply with local regulations and to prevent biological hazards to the testing personnel, it is recommended that these tests be carried out in a shielded enclosure or semi-anechoic chamber.

11.3. Test Procedure

- The equipment to be tested is placed in the center of the enclosure on a wooden table. The equipment is then connected to power and signal leads according to pertinent installation instructions.
- The bilog antenna which is enabling the complete frequency range of 80-1000MHz is placed 3m away from the equipment. The required field strength is determined by placing the field strength meter(s) on top of or directly alongside the equipment under test and monitoring the field strength meter via a remote field strength indicator outside the enclosure while adjusting the continuous-wave to the applicable antennae.
- The test is normally performed with the generating antenna facing each of four sides of the EUT. The polarization of the field generated by the broadband (bilog) antenna necessitates testing each position twice, once with the antenna positioned vertically and again with the antenna positioned horizontally.
- The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised, and able to respond. Sensitive frequencies e.g. clock frequency(ies) and harmonics or frequencies of dominant interest shall be analyzed separately.
- At each of the above conditions, the frequency range is swept 80-1000MHz, pausing to adjust the R.F. signal level or to switch oscillators and antenna. The rate of sweep is in the order of 1.5×10^{-3} decades/s. The sensitive frequencies or frequencies of dominant interest may be discretely analyzed.

11.4. Test Severity Levels

Frequency Band : 80-1000MHz

Level	Test field strength (V/m)
1	1
2	3
3	10
X	Specified
Remark : "X" is an open class.	

12. Electrical Fast Transient/Burst Immunity Measurement (EFT/BURST)

- Final Test Result : **PASS**
- Pass Performance Criteria : **A**
- Required Performance Criteria : B
- Basic Standard : IEC 61000-4-4:2004/A1:2010
- Product Standard : EN 55024:2010
- Level : on Input power ports -- 2
on signal ports and telecommunication ports -- N/A
- Test Voltage : on Input power ports -- $\pm 0.5 / \pm 1.0$ kV
on signal ports and telecommunication ports -- N/A
- Impulse wave shape : 5/50 ns (Tr/Th)
- Impulse frequency : 5 kHz
- Temperature : 22 °C
- Relative Humidity : 48 %
- Atmospheric Pressure : 102 kPa
- Test Date : Mar. 04, 2013
- Test Engineer : Yen-Liang

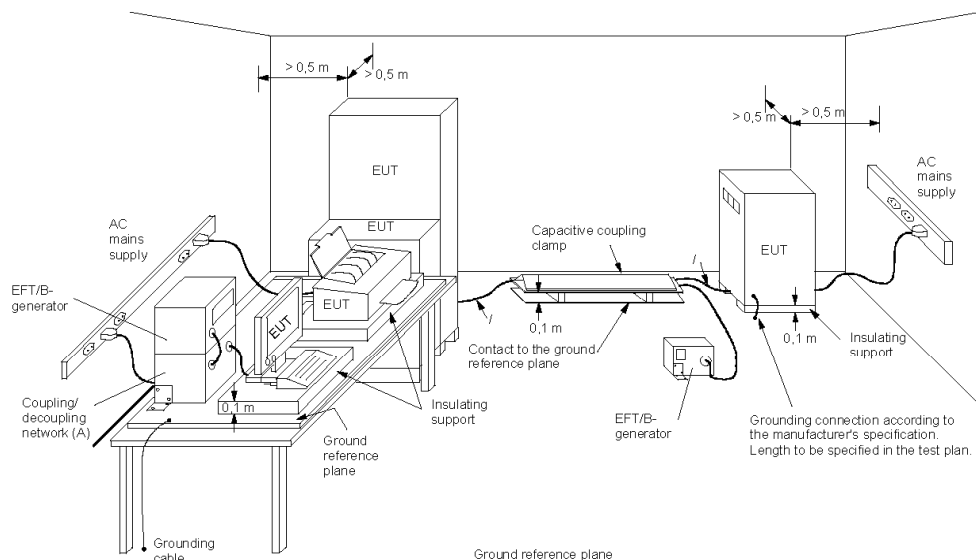
12.1. Test Record

■ Input power port:

Test port	Polarity	Test Level	Voltage (Peak)	Observation
L	+	2	0.5 / 1.0 kV	Normal (No influencing)
	—	2	0.5 / 1.0 kV	Normal (No influencing)
N	+	2	0.5 / 1.0 kV	Normal (No influencing)
	—	2	0.5 / 1.0 kV	Normal (No influencing)
PE	+	2	0.5 / 1.0 kV	Normal (No influencing)
	—	2	0.5 / 1.0 kV	Normal (No influencing)
L+N	+	2	0.5 / 1.0 kV	Normal (No influencing)
	—	2	0.5 / 1.0 kV	Normal (No influencing)
L+PE	+	2	0.5 / 1.0 kV	Normal (No influencing)
	—	2	0.5 / 1.0 kV	Normal (No influencing)
N+PE	+	2	0.5 / 1.0 kV	Normal (No influencing)
	—	2	0.5 / 1.0 kV	Normal (No influencing)
L+N+PE	+	2	0.5 / 1.0 kV	Normal (No influencing)
	—	2	0.5 / 1.0 kV	Normal (No influencing)

Remark : Other cable applied exemption. (Cable lengths < 3m)

12.2. Test setup



IEC 90104

Key

- l* length between clamp and the EUT to be tested (should be $0,5\text{ m} \pm 0,05\text{ m}$)
- (A) location for supply line coupling
- (B) location for signal lines coupling

The EUT was placed on a ground reference plane and was insulated from it by an insulating support about 0.1 m thick. If the EUT is table-top equipment, it was located approximately 0.8 m above the GRP. The GRP. Was a metallic sheet (copper or aluminum) of 0.25 mm, minimum thickness; other metallic may be used but they shall have at least 0.65 mm thickness. It shall project beyond the EUT by at least 0.1 m on all sides and connected to the protective earth. In the SPORTON EMC LAB., We provided 1 mm thickness aluminum ground reference plane or 1 mm thickness stainless steel ground reference plane. The minimum size of the ground reference plane is 1 m x 1 m, the exact size depending on the dimensions of the EUT. It was connected to the protective grounding system. The EUT was arranged and connected according to its functional requirements. The minimum distance between the EUT and other conductive structures, except the GRP. Beneath the EUT, was more than 0.5 m. using the coupling clamp, the minimum distance between the coupling plates and all other conductive structures, except the GRP. Beneath the EUT, was more than 0.5 m. The length of the signal and power lines between the coupling device and the EUT was 1 m or less.

12.3. Test on Power Line

- a. The EFT/B-generator was located on the GRP. The length from the EFT/B-generator to the EUT as not exceeds 1 m.
- b. The EFT/B-generator provides the ability to apply the test voltage in a non-symmetrical condition to the power supply input terminals of the EUT.

12.4. Test on Communication Lines

- a. The coupling clamp is composed of a clamp unit for housing the cable (length more than 3 m), and was placed on the GRP.
- b. The coupling clamp provides the ability of coupling the fast transient/bursts to the cable under test.

12.5. Test Procedure

- a. In order to minimize the effect of environmental parameters on test results, the climatic conditions when test is carrying out shall comply with the following requirements:
 - ambient temperature: 15 °C to 35 °C;
 - relative humidity : 45 % to 75 %;
 - atmospheric pressure : 86 kPa (860 mbar) to 106 kPa (1060 mbar).
- b. In order to minimize the effect of environmental parameters on test results, the electromagnetic environment of the laboratory shall not influence the test results.
- c. The variety and diversity of equipment and systems to be tested make it difficult to establish general criteria for the evaluation of the effects of fast transients/bursts on equipment and systems.
- d. The test results may be classified on the basic of the operating conditions and the functional specification of the equipment under test, according to the following performance criteria :
 - Normal performance within the specification limits.
 - Temporary degradation or loss of function or performance which is self-recoverable.
 - Temporary degradation or loss of function or performance which requires operator intervention or system reset.
 - Degradation or loss of function which is not recoverable due to damage of equipment (components).

12.6. Test Severity Levels

The following test severity levels are recommended for the fast transient/burst test :

Open circuit output test voltage $\pm 10\%$		
Level	On Input power ports	On signal port and telecommunication ports
1	0.5 KV	0.25 KV
2	1.0 KV	0.50 KV
3	2.0 KV	1.00 KV
4	4.0 KV	2.00 KV
X	Specified	Specified
Remark : " X " is an open level.		
The level is subject to negotiation between the user and the manufacturer or is specified by the manufacturer.		

13. Surge Immunity Measurement

- Final Test Result : PASS
- Pass Performance Criteria : A
- Required Performance Criteria : B for Input power ports
: C for signal ports and telecommunication ports
- Basic Standard : IEC 61000-4-5:2005
- Product Standard : EN 55024:2010
- Surge wave form (Tr/Th) : on Input power ports -- 1.2/50 (8/20) μ s
: on signal ports and telecommunication ports -- 10/700 μ s
- Level : on Input power ports -- 3
: on signal ports and telecommunication ports -- N/A
- Test Voltage : on Input power ports -- ± 0.5 / ± 1.0 / ± 2.0 kV
: on signal ports and telecommunication ports -- N/A
- Phase Angle : 0°, 90°, 180°, 270°
- Number of surges : 5 positive and 5 negative pulses
- Pulse Repetition Rate : 1 time / min. (maximum)
- Temperature : 22 °C
- Relative Humidity : 48 %
- Atmospheric Pressure : 102 kPa
- Test Date : Mar. 04, 2013
- Test Engineer : Yen-Liang

13.1. Test Record

■ Input power port:

Test Location	Voltage (kV)	Polarity	Phase Angle				Observation
			0	90	180	270	
L - N	0.5	+	A	A	A	A	Normal (No influencing)
		—	A	A	A	A	Normal (No influencing)
	1.0	+	A	A	A	A	Normal (No influencing)
		—	A	A	A	A	Normal (No influencing)
L - PE	0.5	+	A	A	A	A	Normal (No influencing)
		—	A	A	A	A	Normal (No influencing)
	1.0	+	A	A	A	A	Normal (No influencing)
		—	A	A	A	A	Normal (No influencing)
	2.0	+	A	A	A	A	Normal (No influencing)
		—	A	A	A	A	Normal (No influencing)
N - PE	0.5	+	A	A	A	A	Normal (No influencing)
		—	A	A	A	A	Normal (No influencing)
	1.0	+	A	A	A	A	Normal (No influencing)
		—	A	A	A	A	Normal (No influencing)
	2.0	+	A	A	A	A	Normal (No influencing)
		—	A	A	A	A	Normal (No influencing)

Remark : PE = Earth reference

13.2. Test Severity Levels

Level	Open-circuit test voltage, $\pm 10\%$, KV
1	0.5
2	1.0
3	2.0
4	4.0
x	Specified
Remark : " X " is an open level. This level can be specified in the product specification.	

13.3. Test Procedure

a. Climatic conditions

The climatic conditions shall comply with the following requirements :

- ambient temperature : 15 °C to 35 °C
- relative humidity : 10 % to 75 %
- atmospheric pressure : 86 kPa to 106 kPa (860 mbar to 1060 mbar)

b. Electromagnetic conditions

The electromagnetic environment of the laboratory shall not influence the test results.

c. The test shall be performed according the test plan that shall specify the test set-up with

- generator and other equipment utilized;
- test level (voltage/current);
- generator source impedance;
- internal or external generator trigger;
- number of tests : at least five positive and five negative at the selected points;
- repetition rate : maximum 1/min.
- inputs and outputs to be tested;
- representative operating conditions of the EUT;
- sequence of application of the surge to the circuit;
- phase angle in the case of a.c. power supply;
- actual installation conditions, for example :
AC : neutral earthed,
DC : (+) or (-) earthed to simulated the actual earthing conditions.

d. If not otherwise specified the surges have to be applied synchronized to the voltage phase at the zero-crossing and the peak value of the a.c. voltage wave (positive and negative).

e. The surges have to be applied line to line and line(s) and earth. When testing line to earth, the test voltage has to be applied successively between each of the lines and earth, if there is no other specification.

f. The test procedure shall also consider the non-linear current-voltage characteristics of the equipment under test. Therefore the test voltage has to be increased by steps up to the test level specified in the product standard or test plan.

g. All lower levels including the selected test level shall be satisfied. For testing the secondary protection, the output voltage of the generator shall be increased up to the worst-case voltage breakdown level (let-through level) of the primary protection.

h. If the actual operating signal sources are not available, the may be simulated. Under no circumstances may the test level exceed the product specification. The test shall be carried out according the test plan.

i. To find all critical points of the duty cycle of the equipment, a sufficient number of positive and negative

test pulses shall be applied. For acceptance test previously unstressed equipment shall be used to the protection devices shall be replaced.

13.4. Operating Condition

Full system

14. Conducted Disturbances Induced by Radio-Frequency Field Immunity Measurement (CS)

- Final Test Result : **PASS**
- Pass Performance Criteria : **A**
- Required Performance Criteria : A
- Basic Standard : IEC 61000-4-6:2008
- Product Standard : EN 55024:2010
- Level : 2
- Test Voltage : 3 V (unmodulated, r.m.s) 80% AM (1 kHz)
- Frequency Range : 0.15 MHz to 80 MHz
- Additional Selection Frequency : 0.2, 1, 7.1, 13.56, 21, 27.12, 40.68MHz
- Dwell time : 2.9 seconds
- Frequency step size : 1 % of the preceding frequency value
- Coupling mode : CDN-M2+M3 for Input power ports
- Temperature : 22 °C
- Relative Humidity : 48 %
- Atmospheric Pressure : 102 kPa
- Test Date : Mar. 15, 2013
- Test Engineer : Yen-Liang

14.1. Test Record

Test port	Test field strength level	Test field strength (V rms)	Observation
Input ac power port	2	3	Normal (No influencing)

Remark : Other cable applied exemption. (Cable lengths < 3m)

14.2. Test Severity Levels

Level	Voltage Level (EMF)
1	1 V rms
2	3 V rms
3	10 V rms
x	Specified
Remark : " X " is an open level. This level can be specified in the product specification.	

14.3. Operating Condition

Full system

14.4. Test Procedure

- a. The EUT shall be operated within its intended climatic conditions. The temperature and relative humidity should be recorded.
- b. This test method test can be performed without using a sell shielded enclosure. This is because the disturbance levels applied and the geometry of the setups are not likely to radiated a high amount of energy, especially at the lower frequencies. If under certain circumstances the radiated energy is too high, a shielded enclosure has to be used.
- c. The test shall be performed with the test generator connected to each of the coupling and decoupling devices in turn while the other non-excited RF-input ports of the coupling devices are terminated by a 50 ohm load resistor.
- d. The frequency range is swept from 150 kHz to 80 MHz, using the signal levels established during the setting process, and with the disturbance signal 80% amplitude modulated with a 1kHz sine wave, pausing to adjust the RF-signal level or to switch coupling devices as necessary. The rate of sweep shall no exceed 1.5×10^{-3} decades/s. Where the frequency is swept incrementally, the step size shall no exceed 1% of the start and thereafter 1% of the preceding frequency value.
- e. The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised, and able to respond. Sensitive frequencies e.g. clock frequency(ies) and harmonics or frequencies of dominant interest shall be analyzed separately.
- f. In cases of dispute, the test procedure using a step size not exceeding 1% of the start and thereafter 1% of preceding frequency value shall take precedence.
- g. Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.
- h. The use of special exercising programs is recommended.
- i. Testing shall be performed according to a Test Plan, which shall be included in the test report.
- j. It may be necessary to carry out some investigatory testing in order to establish some aspects of the test plan.

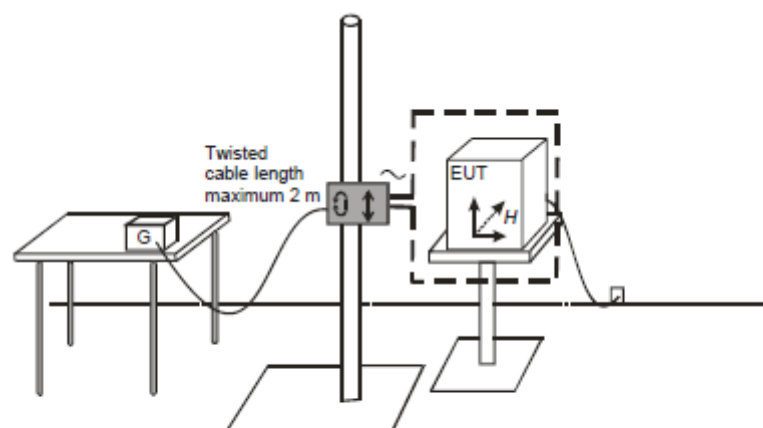
15. Power Frequency Magnetic Field immunity Measurement (PFMF)

- Final Test Result : **PASS**
- Pass Performance Criteria : **A**
- Required Performance Criteria : A
- Basic Standard : IEC 61000-4-8:2009
- Product Standard : EN 55024:2010
- Temperature : 22 °C
- Relative Humidity : 48 %
- Atmospheric Pressure : 102 kPa
- Test Date : Mar. 15, 2013
- Test Engineer : Yen-Liang

15.1. Test Record

Power Frequency Magnetic Field	Testing duration	Coil Orientation	Observation
50/60Hz, 1A/m	1.0 Min	X-axis	Normal (No influencing)
50/60Hz, 1A/m	1.0 Min	Y-axis	Normal (No influencing)
50/60Hz, 1A/m	1.0 Min	Z-axis	Normal (No influencing)

15.2. Test Setup



EUT : Equipment under test G : Test Generator

16. Voltage Dips and Voltage Interruptions Immunity Measurement (DIP)

- Final Test Result : **PASS**
- Pass Performance Criteria : **C** for voltage interruption, **A/A** for voltage dips
- Required Performance Criteria : C for voltage interruption, C/B for voltage dips
- Basic Standard : IEC 61000-4-11:2004
- Product Standard : EN 55024:2010
- Test Port : Input power ports
- Phase Angle : 0°, 45°, 90°, 135°, 180°, 225°, 270°, 315°, 360°
- Temperature : 22 °C
- Relative Humidity : 48 %
- Atmospheric Pressure : 102 kPa
- Test Date : Mar. 04, 2013
- Test Engineer : Yen-Liang

16.1. Test Record of Voltage Interruption

Voltage (V)	Performance Criterion (Phase Angle)									Reduction Voltage	Duration (Periods)	Observation
	0	45	90	135	180	225	270	315	360			
100/240	C	C	C	C	C	C	C	C	C	>95 %	250	After the interruption, the power of EUT was off. The power of the EUT must be reset by the operator.

16.2. Test Record of Voltage Dips

Voltage (V)	Performance Criterion (Phase Angle)									Reduction Voltage	Duration (Periods)	Observation
	0	45	90	135	180	225	270	315	360			
100/240	A	A	A	A	A	A	A	A	A	30 %	25	Normal (No influencing)
100/240	A	A	A	A	A	A	A	A	A	>95 %	0.5	Normal (No influencing)

16.3. Testing Requirement and Procedure

The test was based on IEC 61000-4-11:2004

16.4. Test Conditions

1. Source voltage and frequency : 100/240V, 50Hz, Single phase.
2. Test of interval : 10 sec.
3. Level and duration : Sequency of 3 dips/interrupts.
4. Voltage rise (and fall) time : 1 ~ 5 μ s.

16.5. Operating Condition

Full system

17. Photographs of Test Configuration

17.1. Photographs of AC Powerline Conducted Emissions Test Configuration

- The photographs show the configuration that generates the maximum emission.

FRONT VIEW



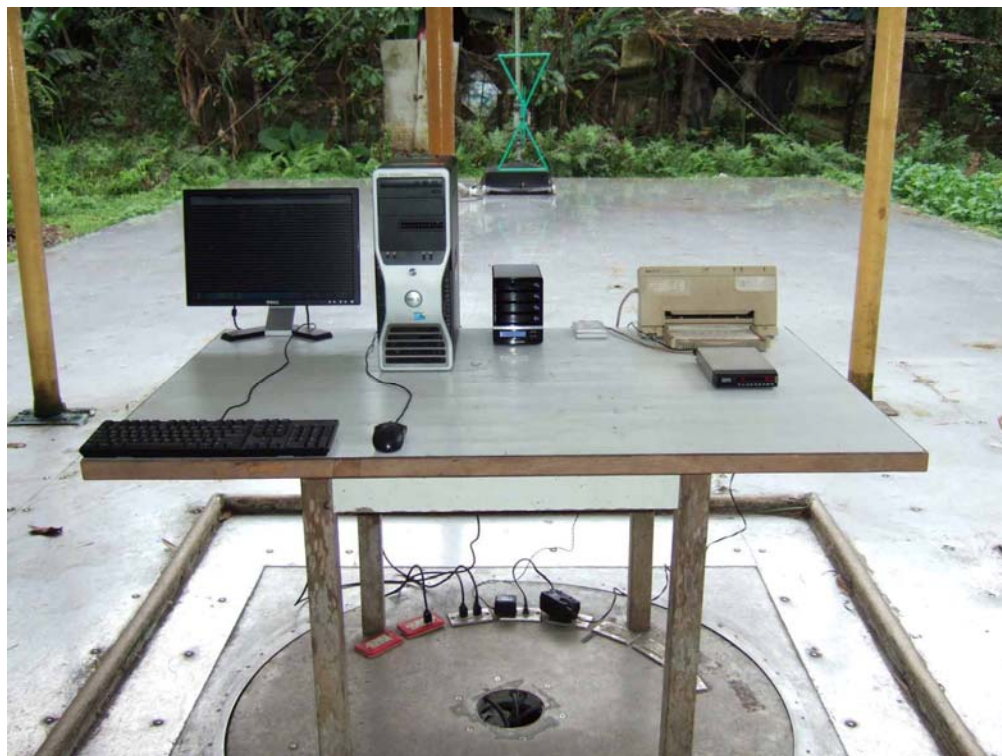
REAR VIEW



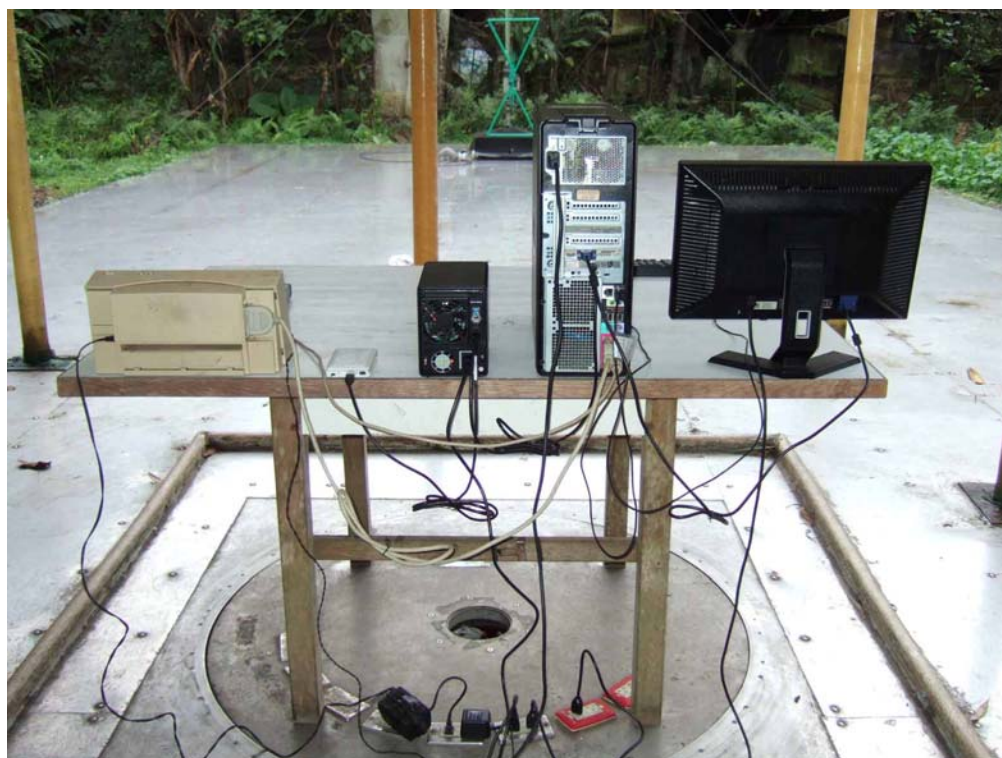
17.2. Photographs of Radiated Emissions Test Configuration

- The photographs show the configuration that generates the maximum emission.
For Below 1GHz

FRONT VIEW



REAR VIEW

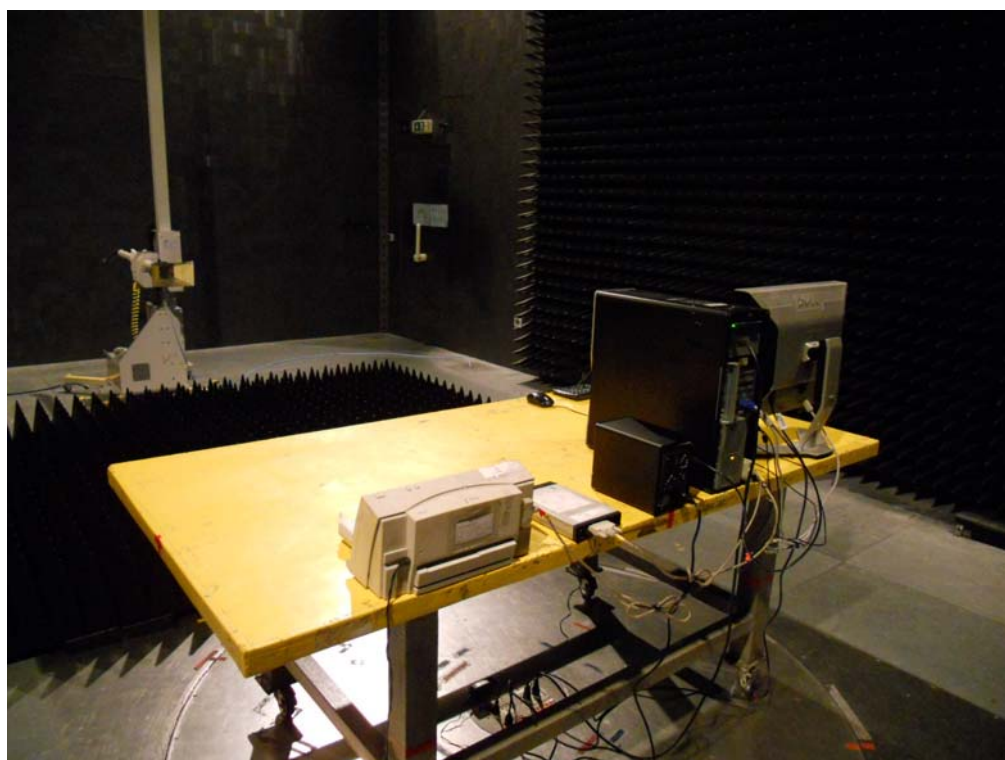


- The photographs show the configuration that generates the maximum emission.
For Above 1GHz

FRONT VIEW



REAR VIEW



17.3. Photographs of Harmonic, Flicker, Surge, Dip Test Configuration

FRONT VIEW



REAR VIEW



17.4. Photographs of ESD Immunity Test Configuration

FRONT VIEW

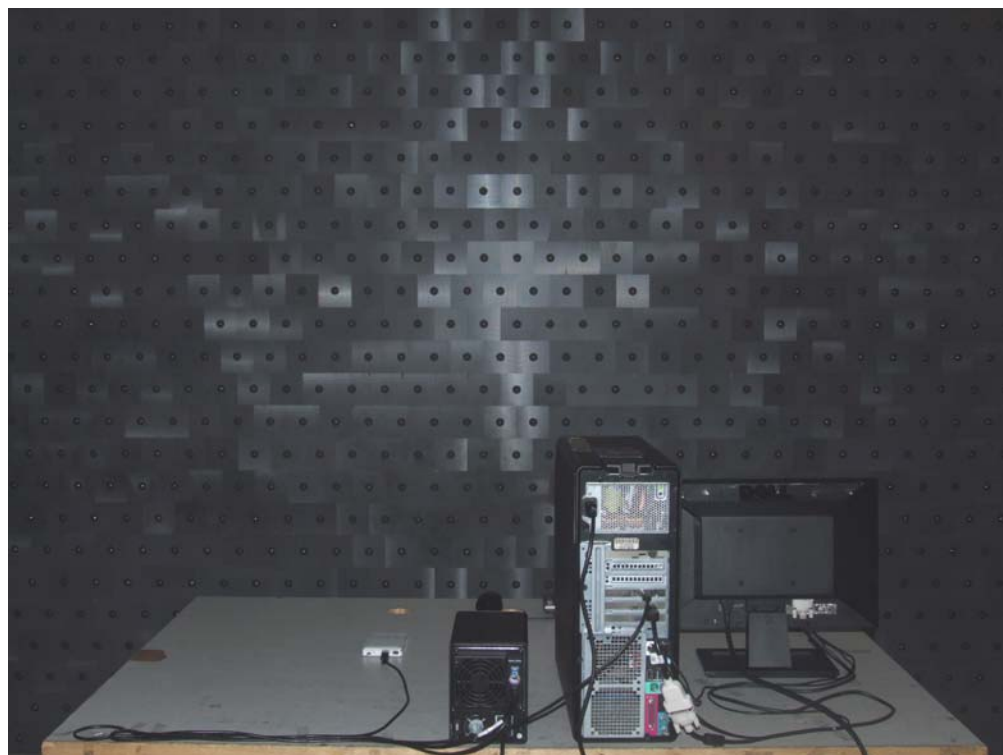


REAR VIEW



17.5. Photographs of RS Immunity Test Configuration

FRONT VIEW



REAR VIEW



17.6. Photographs of EFT/BURST Immunity Test Configuration

FRONT VIEW



REAR VIEW



17.7. Photographs of CS Immunity Test Configuration

FRONT VIEW



REAR VIEW



17.8. Photographs of PFMF immunity test Configuration

FRONT VIEW



REAR VIEW



18. List of Measuring Equipment Used

Conducted Emission

Instrument	Manufacturer	Model No.	Serial No.	Characteristics	Calibration Date	Remark
Receiver	R&S	ESCS 30	100357	9 kHz ~ 2.75 GHz	Nov. 22, 2012	Conduction (CO01-NH)
LISN	SCHAFFNER	NNB41	04/10053	9 kHz ~ 30 MHz	Nov. 20, 2012	Conduction (CO01-NH)
Power Filter	CORCOM	MR12030	N/A	30A*2	NCR	Conduction (CO01-NH)
RF Cable-CON	Suhner Switzerland	RG223/U	CB004	9 kHz ~ 30 MHz	Dec. 12, 2012	Conduction (CO01-NH)

Note: Calibration Interval of instruments listed above is one year.

NCR: NO CALIBRATION REQUEST.

Radiation Emission Below 1GHz

Instrument	Manufacturer	Model No.	Serial No.	Characteristics	Calibration Date	Remark
Open Area Test Site	SPORTON	OATS-10	OS03-NH	30 MHz ~ 1 GHz 10m, 3m	Nov. 11, 2012	Radiation (OS03-NH)
Amplifier	HP	8447D	2944A08292	0.1 MHz ~ 1.3 GHz	May 14, 2012	Radiation (OS03-NH)
Spectrum Analyzer	Advantest	R3261C	81720147	9 kHz ~ 2.6 GHz	Sep. 13, 2012	Radiation (OS03-NH)
Receiver	R&S	ESCS 30	838251/002	9 kHz ~ 2.75 GHz	Oct. 12, 2012	Radiation (OS03-NH)
Bilog Antenna	CHASE	CBL6112D	25234	30 MHz ~ 2 GHz	Feb. 27, 2012	Radiation (OS03-NH)
Turn Table	EMCO	2080	9805-2065	0 ~ 360 degree	NCR	Radiation (OS03-NH)
Antenna Mast	EMCO	2075	9804-2151	1 m ~ 4 m	NCR	Radiation (OS03-NH)
RF Cable-R10m	HSCN	RG213U	2X11N	30 MHz ~ 1 GHz	Aug. 09, 2012	Radiation (OS03-NH)

Note: Calibration Interval of instruments listed above is one year.

NCR: NO CALIBRATION REQUEST.

Radiation Emission Above 1GHz

Instrument	Manufacturer	Model No.	Serial No.	Characteristics	Calibration Date	Remark
Amplifier	Agilent	8449B	3008A02120	1GHz ~ 26.5GHz	Aug. 16, 2012	Radiation (03CH03-HY)
Horn Antenna	EMCO	3115	6741	1GHz ~ 18GHz	May 30, 2012	Radiation (03CH03-HY)
RF Cable-high	SUHNER	SUCOFLEX 106	03CH03-HY	1GHz ~ 40GHz	Jan. 17, 2013	Radiation (03CH03-HY)
Spectrum Analyzer	R&S	FSP30	100793	9kHz ~ 30GHz	Sep. 26, 2012	Radiation (03CH03-HY)

Note: Calibration Interval of instruments listed above is one year.

EMS

Instrument	Manufacturer	Model No.	Serial No.	Characteristics	Calibration Date	Remark
ESD Generator	TESEQ	NSG 437	102	Air: 0KV~30KV Contact: 0KV~15KV	Oct. 18, 2012	ESD
Amplifier	AMPLIFIER& RESEARCH	250W1000A	0325368	80MHz~1GHz	Sep. 12, 2012	RS
DUAL DIRECTIONAL COUPLER	FARNKONIA	FLH200/100(C 5982)	11927	80MHz~1GHz	Sep. 13, 2012	RS
S.G.	ROHDE& SCHWARZ	SML03	103349	9kHz~3.3GHz	Sep. 11, 2012	RS
METER	HP	438A	3513U04050	100kHz~26.5GHz	Sep. 13, 2012	RS
POWER Sensor	HP	8481D	3318A13140	10MHz~18GHz	Sep. 13, 2012	RS
POWER Sensor	HP	8482A	3318A26464	100kHz~4.2GHz	Sep. 13, 2012	RS
Attenuator	HP	8491A	53603	3dB	N/A	RS
EMC PRO System	KEYTEK	EMC PRO	0609221	0KV~4.4KV	Oct. 26, 2012	EFT
SURGE Generator Bi-Wave	KEYTEK	EMC PRO	0609221	0KV -6KV/2Ω 0V-500V/12Ω	Oct. 26, 2012	SURGE
Conducted Immunity Test System	SCHAFFNER	NSG2070	1091	100KHz~250MHz FM 1KHz 80%	Apr. 12, 2012	CS
Attenuator	EM TEST	75W-DC-250 MHz 06	0004166A	150kHz~230MHz	Apr. 16, 2012	CS
Koppel- Eutkoppelnetzwerk	FRANKONIA	CDN M2+M3	A3011018	150kHz~230MHz	Apr. 17, 2012	CS
Magnetic Field Antenna	FCC	F-1000-4-8/9/10-L-1M	9830	0~125A	Apr. 12, 2012	Magnetic
Magnetic Generator	FCC	F-1000-4-8-G-125A	05004	0~125A	Apr. 12, 2012	Magnetic
EMC PRO System	KEYTEK	EMC PRO	0609221	230VA/50Hz/60Hz 0% Open/5Sec 0% Short/5Sec 40% 0.10Sec 70%/ 0.01Sec	Oct. 26, 2012	DIP
Harmonic/Flicker Test System	EMC PARTNER	Harmonics -1000	088	4000VA 16A PEAK	Sep. 17, 2012	Harmonics, Flicker

Note: Calibration Interval of instruments listed above is one year.

19. Uncertainty of Test Site

Emission Test Measurement Uncertainty

Uncertainty of Conducted Emission Measurement from 150kHz to 30MHz

Contribution	Uncertainty of x_i		$u(x_i)$
	dB	Probability Distribution	
Receiver reading	0.20	Normal(k=2)	0.10
Cable loss	0.19	Normal(k=2)	0.10
AMN insertion loss	2.50	Rectangular	0.63
Receiver Spec	1.50	Rectangular	0.43
Site imperfection	1.75	Rectangular	1.01
Mismatch	+0.44/-0.46	U-shape	0.32
combined standard uncertainty $U_c(y)$			1.31
Measuring uncertainty for a level of confidence of 95% $U=2U_c(y)$			2.62

Uncertainty of Radiated Emission Measurement from 30MHz to 1000MHz

Contribution	Uncertainty of x_i		$u(x_i)$
	dB	Probability Distribution	
Receiver reading	0.08	Normal(k=2)	0.04
Antenna factor calibration	0.96	Normal(k=2)	0.48
Cable loss calibration	0.17	Normal(k=2)	0.09
Pre Amplifier Gain calibration	0.21	Normal(k=2)	0.11
RCV/SPA specification	2.50	Rectangular	0.72
Antenna Factor Interpolation for Frequency	1.00	Rectangular	0.29
Site imperfection	1.95	Rectangular	1.13
Mismatch	+0.39/-0.41	U-shaped	0.28
combined standard uncertainty $U_c(y)$			1.48
Measuring uncertainty for a level of confidence of 95% $U=2U_c(y)$			2.96

Uncertainty of Radiated Emission Measurement from 1 GHz to 6 GHz						
Input quantity	X_i	Uncertainty of x_i		$u(x_i)$	c_i	$c_i u(x_i)$
		dB	Probability distribution function	dB		dB
Spectrum reading	V_r	± 0.1	k=1	0.10	1	0.10
Attenuation: antenna-receiver	L_c	± 0.1	k=2	0.05	1	0.05
Receiver corrections:	δRC	± 1.0	k=2	0.50	1	0.50
Antenna factor	AF	± 1.3	k=2	0.65	1	0.65
Horn antenna corrections:						
AF frequency interpolation	δAF_f	± 0.5	Rectangular	0.29	1	0.29
AF height deviations	δAF_h	± 0.5	Rectangular	0.29	1	0.29
Directivity difference	δA_{dir}	± 1.0	Rectangular	0.58	1	0.58
Phase centre location	δA_{ph}	± 1.0	Rectangular	0.58	1	0.58
Cross-polarization	δA_{cp}	± 0.9	Rectangular	0.52	1	0.52
Mismatch: antenna-receiver	δM	+0.9/-1.0	U-shaped	0.67	1	0.67
Site corrections						
Site imperfections	δSA	± 5.6	Triangular	2.29	1	2.29
Measurement system repeatability	R	± 0.20	Rectangular	0.117	1	0.117
Cable loss	C	± 0.68	Rectangular	0.394	1	0.394
Preamplifier factor	PA	± 0.06	Rectangular	0.037	1	0.037
$u_c(y) =$					2.7	
$2 u_c(y) =$					5.4	

**Immunity Test Measurement Uncertainty****ESD Immunity (IEC 61000-4-2)****Negative Discharge Current**

From Standard			
2kV	First Peak Current	Current at 30ns	Current at 60ns
Nominal	7.5	4	2
Min	6.75	2.8	1.4
Max	8.25	5.2	2.6
Tolerance in %	10%	30%	30%

From calibration certificate					
Measured First Peak Current	1st Peak Worst case. +5%	Measured Current at 30ns	30ns Worst case. +5%	Measured Current at 60ns	60ns Worst case. +5%
7.48	7.85	4.2	4.41	2.01	2.11
	6.75		2.8		1.4
	8.25		5.2		2.6

4kV	First Peak Current	Current at 30ns	Current at 60ns
Nominal	15	8	4
Min	13.5	5.6	2.8
Max	16.5	10.4	5.2
Tolerance in %	10%	30%	30%

First Peak Current	1st Peak Worst case. +5%	Measured Current at 30ns	30ns Worst case. +5%	Measured Current at 60ns	60ns Worst case. +5%
15.12	15.88	8.03	8.43	3.68	3.86
	13.5		5.6		2.8
	16.5		10.4		5.2

6kV	First Peak Current	Current at 30ns	Current at 60ns
Nominal	22.5	12	6
Min	20.25	8.4	4.2
Max	24.75	15.6	7.8
Tolerance in %	10%	30%	30%

First Peak Current	1st Peak Worst case. +5%	Measured Current at 30ns	30ns Worst case. +5%	Measured Current at 60ns	60ns Worst case. +5%
22.78	23.92	12.37	12.99	5.45	5.72
	20.25		8.4		4.2
	24.75		15.6		7.8

8kV	First Peak Current	Current at 30ns	Current at 60ns
Nominal	30	16	8
Min	27	11.2	5.6
Max	33	20.8	10.4
Tolerance in %	10%	30%	30%

First Peak Current	1st Peak Worst case. +5%	Measured Current at 30ns	30ns Worst case. +5%	Measured Current at 60ns	60ns Worst case. +5%
30.26	31.77	16.13	16.94	7.39	7.76
	27		11.2		5.6
	33		20.8		10.4

Negative Discharge Voltage

Standard Parameters				Measured Values
Indicated Voltage.	Tolerance.	Max.	Min.	
kV	%	kV	kV	kV
2	10	2.20	1.80	2.05
4	10	4.40	3.60	4.027
6	10	6.60	5.40	5.955
8	10	8.80	7.20	7.916
15	10	16.50	13.50	14.839

Negative Rise Time

Standard Parameters		Measured Values			
T max.	1ns	Indicated Voltage.	Measured Rise Time.	Worst Case max. +6%	Worst Case min. -6%
T min	0.7ns	2kV	0.851	0.902	0.799
		4kV	0.780	0.268	0.733
		6kV	0.750	0.795	0.705
		8kV	0.772	0.818	0.726

It has been demonstrated that the ESD generator meets the specified requirements in the standard with at least a 95% confidence

RF Radiated Immunity (IEC 61000-4-3)

Symbol	Source of Uncertainty	Value	Probability distribution	Divisor	ui(y)
FSM	Felds Strength monitor	1.5	Normal 2	2.000	0.75
FSAW	Field Strength acceptability window	0.50	Rectangular	1.732	0.29
PAH	Power Amplifier Harmonics	0.50	Rectangular	1.732	0.29
RS	Measurement System Repeatability	0.50	Normal 1	1.000	0.50
REUT	Repeatability of EUT	0.00	Normal 1	1.000	0.00
uc(FS)	Combined Standard Uncertainty	-	Normal	-	0.83
U(FS)	Expanded Uncertainty	-	Normal k= 2		1.66

Specified Level (V/m)	Test level (V/m)
For 1 Volts	1.25
For 3 Volts	3.33
For 10 Volts	11.22

RF Conducted Immunity (IEC 61000-4-6)

Symbol	Source of Uncertainty	Value	Probability distribution	Divisor	$u_i(y)$
S_A	Spectrum Analyzer	1.50	Rectangular	1.732	0.87
C_C	Current coil Calibration	1.00	Normal 2	2.000	0.50
M	Mismatch	-0.5	U-shaped	1.414	-0.35
M	Mismatch	-0.3	U-shaped	1.414	-0.35
R_S	Measurement System Repeatability	0.50	Normal 1	1.000	0.50
R_{EUT}	Repeatability of EUT	0.00	Normal 1	1.000	0.00
$u_c(F_S)$	Combined Standard Uncertainty	-	Normal	-	1.57
$U(F_S)$	Expanded Uncertainty	-	normal k= 2		3.14

Specified Level	Test level (V)
For 1 Volts	1.30
For 3 Volts	3.88
For 10 Volts	12.15

APPENDIX A. Photographs of EUT

